RF Test Report

For

Applicant Name:	**Shenzhen DOOGEE Hengtong Technology CO.,LTD**
Address:	B, 2/F, Building A4, Silicon Valley Power Digital Industrial Park, No. 22, Longhua New District, Shenzhen, China
EUT Name:	Tablet
Brand Name:	DOOGEE
Model Number:	R10, R10Pro, R10S, R10E
Series Model Number:	Refer to section 2

Issued By

Company Name:	**BTF Testing Lab (Shenzhen) Co., Ltd.**
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Report Number:	BTF230607R00202
Test Standards:	47 CFR Part 15.247
Test Conclusion:	Pass
FCC ID:	2AX4YR10
Test Date:	2023-04-22 to 2023-05-08
Date of Issue:	2023-06-07
Prepared By:	Elma.Yang
	elma.yang/ Project Engineer
Date:	2023-06-07
Approved By:	Ryan.CJ
	Ryan.CJ/ EMC Manager
Date:	2023-06-07

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Revision History		
Version	Issue Date	Revisions Content
R_V0	2023-06-07	Original
Note: Once the revision has been made, then previous versions reports are invalid.		

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1 Introduction

1.1 Identification of Testing Laboratory

Company Name:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Phone Number:	+86-0755-23146130
Fax Number:	+86-0755-23146130

1.2 Identification of the Responsible Testing Location

Company Name:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Phone Number:	+86-0755-23146130
Fax Number:	+86-0755-23146130
FCC Registration Number:	518915
Designation Number:	CN1330

1.3 Announcement

(1) The test report reference to the report template version v0.
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(4) This document may not be altered or revised in any way unless done so by BTF and all revisions are duly noted in the revisions section.
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(6) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.

2 Product Information

2.1 Application Information

Company Name:	Shenzhen DOOGEE Hengtong Technology CO.,LTD
Address:	B, 2/F, Building A4, Silicon Valley Power Digital Industrial Park, No. 22, Longhua New District, Shenzhen, China

2.2 Manufacturer Information

Company Name:	Shenzhen DOOGEE Hengtong Technology CO.,LTD
Address:	B, 2/F, Building A4, Silicon Valley Power Digital Industrial Park, No. 22, Longhua New District, Shenzhen, China

2.3 Factory Information

Company Name:	Shenzhen DOOGEE Hengtong Technology CO.,LTD
Address:	B, 2/F, Building A4, Silicon Valley Power Digital Industrial Park, No. 22, Longhua New District, Shenzhen, China

2.4 General Description of Equipment under Test (EUT)

EUT Name:	Tablet
Test Model Number:	R10
Series Model Number:	R10, R10Pro, R10S, R10E
Diff:	There is no difference except the name of the model. All tests are made with the R10 model

2.5 Technical Information

Power Supply:	DC 3.8V from battery or DC 9V from adapter
Power Adaptor:	Input: 100~240V 50/60Hz 0.6A Output: 5V⎓3A, 9V⎓2.22A, 12V⎓1.67A
Operation Frequency:	2402MHz to 2480MHz
Number of Channels:	40
Modulation Type:	GFSK
Antenna Type:	PIFA antenna
Antenna Gain#:	1.51 dBi

Note:

#: The antenna gain provided by the applicant, and the laboratory will not be responsible for the accumulated calculation results which covers the information provided by the applicant.

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3 Summary of Test Results

3.1 Test Standards

The tests were performed according to following standards: **47 CFR Part 15.247:** Operation within the bands 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz

3.2 Uncertainty of Test

Item	Measurement Uncertainty
Conducted Emission (150 kHz-30 MHz)	±2.64dB
The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.	

3.3 Summary of Test Result

Item	Standard	Requirement	Result
Antenna requirement	47 CFR Part 15.247	Part 15.203	Pass
Conducted Emission at AC power line	47 CFR Part 15.247	47 CFR 15.207(a)	Pass
Occupied Bandwidth	47 CFR Part 15.247	47 CFR 15.215(c)	Pass
Maximum Conducted Output Power	47 CFR Part 15.247	47 CFR 15.247(b)(1)	Pass
Channel Separation	47 CFR Part 15.247	47 CFR 15.247(a)(1)	Pass
Number of Hopping Frequencies	47 CFR Part 15.247	47 CFR 15.247(a)(1)(iii)	Pass
Dwell Time	47 CFR Part 15.247	47 CFR 15.247(a)(1)(iii)	Pass
Emissions in non-restricted frequency bands	47 CFR Part 15.247	47 CFR 15.247(d)	Pass
Band edge emissions (Radiated)	47 CFR Part 15.247	47 CFR 15.247(d)	Pass
Emissions in restricted frequency bands (below 1GHz)	47 CFR Part 15.247	47 CFR 15.247(d)	Pass
Emissions in restricted frequency bands (above 1GHz)	47 CFR Part 15.247	47 CFR 15.247(d)	Pass

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4 Test Configuration

4.1 Test Equipment List

Conducted Emission at AC power line					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Pulse Limiter	SCHWARZBECK	VTSD 9561-F	00953	2022-11-24	2023-11-23
Coaxial Switcher	SCHWARZBECK	CX210	CX210	2022-11-24	2023-11-23
V-LISN	SCHWARZBECK	NSLK 8127	01073	2022-11-24	2023-11-23
LISN	AFJ	LS16/110VAC	16010020076	2023-02-23	2024-02-22
EMI Receiver	ROHDE&SCHWARZ	ESCI3	101422	2022-11-24	2023-11-23

Occupied Bandwidth					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
RFTest software	/	V1.00	/	/	/
RF Control Unit	Techy	TR1029-1	/	2022-11-24	2023-11-23
RF Sensor Unit	Techy	TR1029-2	/	2022-11-24	2023-11-23
Programmable constant temperature and humidity box	ZZCKONG	ZZ-K02A	20210928007	2022-11-24	2023-11-23
Adjustable Direct Current Regulated Power Supply	Dongguan Tongmen Electronic Technology Co., LTD	etm-6050c	20211026123	2022-11-24	2023-11-23
WIDEBAND RADIO COMMNUNICATION TESTER	Rohde & Schwarz	CMW500	161997	2022-11-24	2023-11-23
MXA Signal Analyzer	KEYSIGHT	N9020A	MY50410020	2022-11-24	2023-11-23

Maximum Conducted Output Power					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
RFTest software	/	V1.00	/	/	/
RF Control Unit	Techy	TR1029-1	/	2022-11-24	2023-11-23
RF Sensor Unit	Techy	TR1029-2	/	2022-11-24	2023-11-23
Programmable constant temperature and humidity box	ZZCKONG	ZZ-K02A	20210928007	2022-11-24	2023-11-23
Adjustable Direct Current Regulated Power Supply	Dongguan Tongmen Electronic Technology Co., LTD	etm-6050c	20211026123	2022-11-24	2023-11-23
WIDEBAND RADIO COMMNUNICATION TESTER	Rohde & Schwarz	CMW500	161997	2022-11-24	2023-11-23
MXA Signal Analyzer	KEYSIGHT	N9020A	MY50410020	2022-11-24	2023-11-23

Channel Separation					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
RFTest software	/	V1.00	/	/	/

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RF Control Unit	Techy	TR1029-1	/	2022-11-24	2023-11-23
RF Sensor Unit	Techy	TR1029-2	/	2022-11-24	2023-11-23
Programmable constant temperature and humidity box	ZZCKONG	ZZ-K02A	20210928007	2022-11-24	2023-11-23
Adjustable Direct Current Regulated Power Supply	Dongguan Tongmen Electronic Technology Co., LTD	etm-6050c	20211026123	2022-11-24	2023-11-23
WIDEBAND RADIO COMMNUNICATION TESTER	Rohde & Schwarz	CMW500	161997	2022-11-24	2023-11-23
MXA Signal Analyzer	KEYSIGHT	N9020A	MY50410020	2022-11-24	2023-11-23

Number of Hopping Frequencies					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
RFTest software	/	V1.00	/	/	/
RF Control Unit	Techy	TR1029-1	/	2022-11-24	2023-11-23
RF Sensor Unit	Techy	TR1029-2	/	2022-11-24	2023-11-23
Programmable constant temperature and humidity box	ZZCKONG	ZZ-K02A	20210928007	2022-11-24	2023-11-23
Adjustable Direct Current Regulated Power Supply	Dongguan Tongmen Electronic Technology Co., LTD	etm-6050c	20211026123	2022-11-24	2023-11-23
WIDEBAND RADIO COMMNUNICATION TESTER	Rohde & Schwarz	CMW500	161997	2022-11-24	2023-11-23
MXA Signal Analyzer	KEYSIGHT	N9020A	MY50410020	2022-11-24	2023-11-23

Dwell Time					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
RFTest software	/	V1.00	/	/	/
RF Control Unit	Techy	TR1029-1	/	2022-11-24	2023-11-23
RF Sensor Unit	Techy	TR1029-2	/	2022-11-24	2023-11-23
Programmable constant temperature and humidity box	ZZCKONG	ZZ-K02A	20210928007	2022-11-24	2023-11-23
Adjustable Direct Current Regulated Power Supply	Dongguan Tongmen Electronic Technology Co., LTD	etm-6050c	20211026123	2022-11-24	2023-11-23
WIDEBAND RADIO COMMNUNICATION TESTER	Rohde & Schwarz	CMW500	161997	2022-11-24	2023-11-23
MXA Signal Analyzer	KEYSIGHT	N9020A	MY50410020	2022-11-24	2023-11-23

Emissions in non-restricted frequency bands

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Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
RFTest software	/	V1.00	/	/	/
RF Control Unit	Techy	TR1029-1	/	2022-11-24	2023-11-23
RF Sensor Unit	Techy	TR1029-2	/	2022-11-24	2023-11-23
Programmable constant temperature and humidity box	ZZCKONG	ZZ-K02A	20210928007	2022-11-24	2023-11-23
Adjustable Direct Current Regulated Power Supply	Dongguan Tongmen Electronic Technology Co., LTD	etm-6050c	20211026123	2022-11-24	2023-11-23
WIDEBAND RADIO COMMNUNICATION TESTER	Rohde & Schwarz	CMW500	161997	2022-11-24	2023-11-23
MXA Signal Analyzer	KEYSIGHT	N9020A	MY50410020	2022-11-24	2023-11-23

Band edge emissions (Radiated)					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Coaxial cable Multiflex 141	Schwarzbeck	N/SMA 0.5m	517386	2023-03-24	2024-03-23
Preamplifier	SCHWARZBECK	BBV9744	00246	2022-11-24	2023-11-23
RE Cable	REBES Talent	UF1-SMASMAM-10m	21101566	2022-11-24	2023-11-23
RE Cable	REBES Talent	UF2-NMNM-10m	21101570	2022-11-24	2023-11-23
RE Cable	REBES Talent	UF1-SMASMAM-1m	21101568	2022-11-24	2023-11-23
RE Cable	REBES Talent	UF2-NMNM-1m	21101576	2022-11-24	2023-11-23
RE Cable	REBES Talent	UF2-NMNM-2.5m	21101573	2022-11-24	2023-11-23
POSITIONAL CONTROLLER	SKET	PCI-GPIB	/	/	/
Horn Antenna	SCHWARZBECK	BBHA9170	01157	2021-11-28	2023-11-27
EMI TEST RECEIVER	ROHDE&SCHWARZ	ESCI7	101032	2022-11-24	2023-11-23
SIGNAL ANALYZER	ROHDE&SCHWARZ	FSQ40	100010	2022-11-24	2023-11-23
POSITIONAL CONTROLLER	SKET	PCI-GPIB	/	/	/
Broadband Preamplilifier	SCHWARZBECK	BBV9718D	00008	2023-03-24	2024-03-23
Horn Antenna	SCHWARZBECK	BBHA9120D	2597	2022-05-22	2024-05-21
EZ_EMC	Frad	FA-03A2 RE+	/	/	/
POSITIONAL CONTROLLER	SKET	PCI-GPIB	/	/	/
Log periodic antenna	SCHWARZBECK	VULB 9168	01328	2021-11-28	2023-11-27

Emissions in restricted frequency bands (below 1GHz)					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Coaxial cable Multiflex 141	Schwarzbeck	N/SMA 0.5m	517386	2023-03-24	2024-03-23
Preamplifier	SCHWARZBECK	BBV9744	00246	2022-11-24	2023-11-23

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RE Cable	REBES Talent	UF1-SMASMAM-10m	21101566	2022-11-24	2023-11-23
RE Cable	REBES Talent	UF2-NMNM-10m	21101570	2022-11-24	2023-11-23
RE Cable	REBES Talent	UF1-SMASMAM-1m	21101568	2022-11-24	2023-11-23
RE Cable	REBES Talent	UF2-NMNM-1m	21101576	2022-11-24	2023-11-23
RE Cable	REBES Talent	UF2-NMNM-2.5m	21101573	2022-11-24	2023-11-23
POSITIONAL CONTROLLER	SKET	PCI-GPIB	/	/	/
Horn Antenna	SCHWARZBECK	BBHA9170	01157	2021-11-28	2023-11-27
EMI TEST RECEIVER	ROHDE&SCHWARZ	ESCI7	101032	2022-11-24	2023-11-23
SIGNAL ANALYZER	ROHDE&SCHWARZ	FSQ40	100010	2022-11-24	2023-11-23
POSITIONAL CONTROLLER	SKET	PCI-GPIB	/	/	/
Broadband Preamplilifier	SCHWARZBECK	BBV9718D	00008	2023-03-24	2024-03-23
Horn Antenna	SCHWARZBECK	BBHA9120D	2597	2022-05-22	2024-05-21
EZ_EMC	Frad	FA-03A2 RE+	/	/	/
POSITIONAL CONTROLLER	SKET	PCI-GPIB	/	/	/
Log periodic antenna	SCHWARZBECK	VULB 9168	01328	2021-11-28	2023-11-27

Emissions in restricted frequency bands (above 1GHz)					
Equipment	**Manufacturer**	**Model No**	**Inventory No**	**Cal Date**	**Cal Due Date**
Coaxial cable Multiflex 141	Schwarzbeck	N/SMA 0.5m	517386	2023-03-24	2024-03-23
Preamplifier	SCHWARZBECK	BBV9744	00246	2022-11-24	2023-11-23
RE Cable	REBES Talent	UF1-SMASMAM-10m	21101566	2022-11-24	2023-11-23
RE Cable	REBES Talent	UF2-NMNM-10m	21101570	2022-11-24	2023-11-23
RE Cable	REBES Talent	UF1-SMASMAM-1m	21101568	2022-11-24	2023-11-23
RE Cable	REBES Talent	UF2-NMNM-1m	21101576	2022-11-24	2023-11-23
RE Cable	REBES Talent	UF2-NMNM-2.5m	21101573	2022-11-24	2023-11-23
POSITIONAL CONTROLLER	SKET	PCI-GPIB	/	/	/
Horn Antenna	SCHWARZBECK	BBHA9170	01157	2021-11-28	2023-11-27
EMI TEST RECEIVER	ROHDE&SCHWARZ	ESCI7	101032	2022-11-24	2023-11-23
SIGNAL ANALYZER	ROHDE&SCHWARZ	FSQ40	100010	2022-11-24	2023-11-23
POSITIONAL CONTROLLER	SKET	PCI-GPIB	/	/	/
Broadband Preamplilifier	SCHWARZBECK	BBV9718D	00008	2023-03-24	2024-03-23
Horn Antenna	SCHWARZBECK	BBHA9120D	2597	2022-05-22	2024-05-21
EZ_EMC	Frad	FA-03A2 RE+	/	/	/
POSITIONAL CONTROLLER	SKET	PCI-GPIB	/	/	/

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Log periodic antenna	SCHWARZBECK	VULB 9168	01328	2021-11-28	2023-11-27

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4.2 Test Auxiliary Equipment

The EUT was tested as an independent device.

4.3 Test Modes

Tested mode, channel information		
Mode	**Channel**	**Frequency (MHz)**
GFSK	Low :CH1	2402
	Middle: CH40	2441
	High: CH79	2480
π/4 DQPSK	Low :CH1	2402
	Middle: CH40	2441
	High: CH79	2480
8DPSK	Low :CH1	2402
	Middle: CH40	2441
	High: CH79	2480

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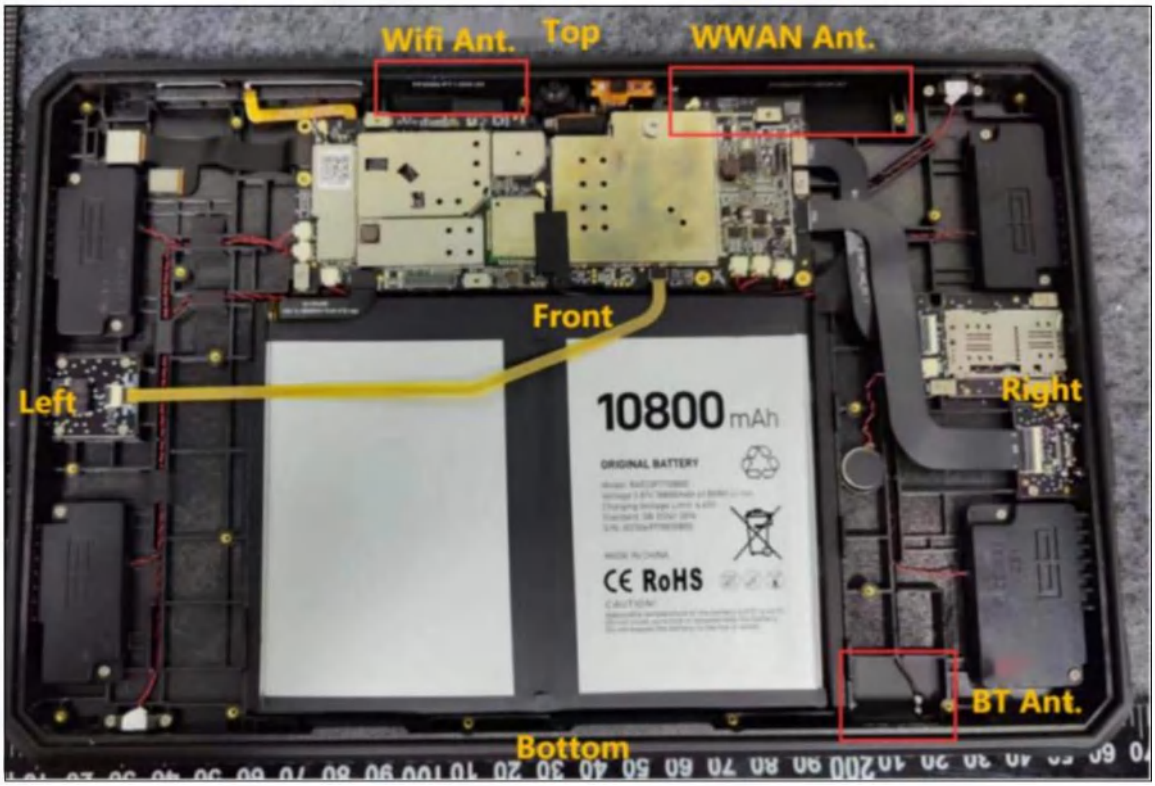
5 Evaluation Results (Evaluation)

5.1 Antenna requirement

Test Requirement:	An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section.

5.1.1 Conclusion:



6 Radio Spectrum Matter Test Results (RF)

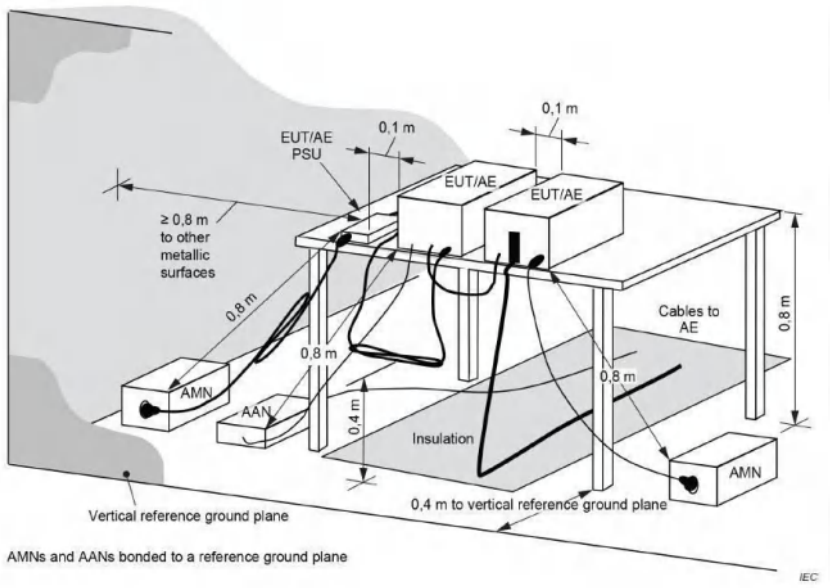
6.1 Conducted Emission at AC power line

Test Requirement:	Except as shown in paragraphs (b)and (c)of this section, for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50 μH/50 ohms line impedance stabilization network (LISN).
Test Method:	Refer to ANSI C63.10-2013 section 6.2, standard test method for ac power-line conducted emissions from unlicensed wireless devices
Test Limit:	Frequency of emission (MHz) / Conducted limit (dBμV): Quasi-peak / Average 0.15-0.5: 66 to 56* / 56 to 46* 0.5-5: 56 / 46 5-30: 60 / 50 *Decreases with the logarithm of the frequency.

6.1.1 E.U.T. Operation:

Operating Environment:	
Temperature:	22.4 °C
Humidity:	52.7 %
Atmospheric Pressure:	1010 mbar

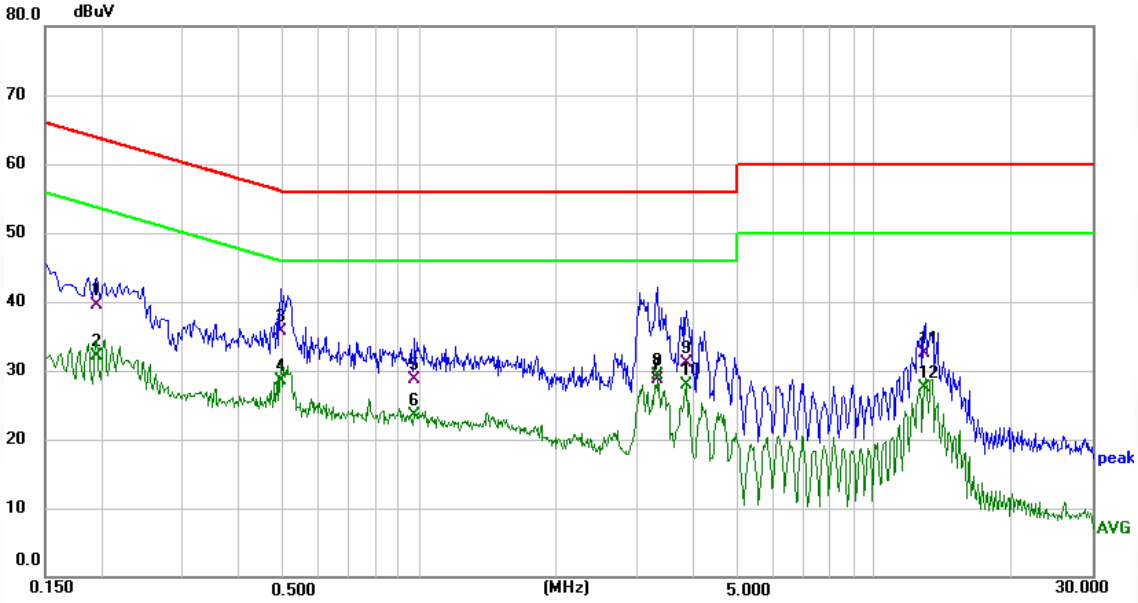
6.1.2 Test Setup Diagram:



6.1.3

TM1 / Line: Line / Band: 2.4G / BW: 1 / CH: M

Polarity: L



No.	Frequency (MHz)	Reading Level(dBuV)	Factor (dB)	Measure-ment(dBuV)	Limit (dBuV)	Over (dB)	Detector	Comment
1	0.1940	29.97	9.47	39.44	63.86	-24.42	QP	
2	0.1940	22.54	9.47	32.01	53.86	-21.85	AVG	
3	0.4940	25.88	9.73	35.61	56.10	-20.49	QP	
4	0.4940	18.83	9.73	28.56	46.10	-17.54	AVG	
5	0.9780	18.76	9.91	28.67	56.00	-27.33	QP	
6	0.9780	13.57	9.91	23.48	46.00	-22.52	AVG	
7	3.3300	18.82	9.91	28.73	56.00	-27.27	QP	
8 *	3.3300	19.46	9.91	29.37	46.00	-16.63	AVG	
9	3.8500	21.32	9.74	31.06	56.00	-24.94	QP	
10	3.8500	18.07	9.74	27.81	46.00	-18.19	AVG	
11	12.8979	22.53	9.88	32.41	60.00	-27.59	QP	
12	12.8979	17.72	9.88	27.60	50.00	-22.40	AVG	

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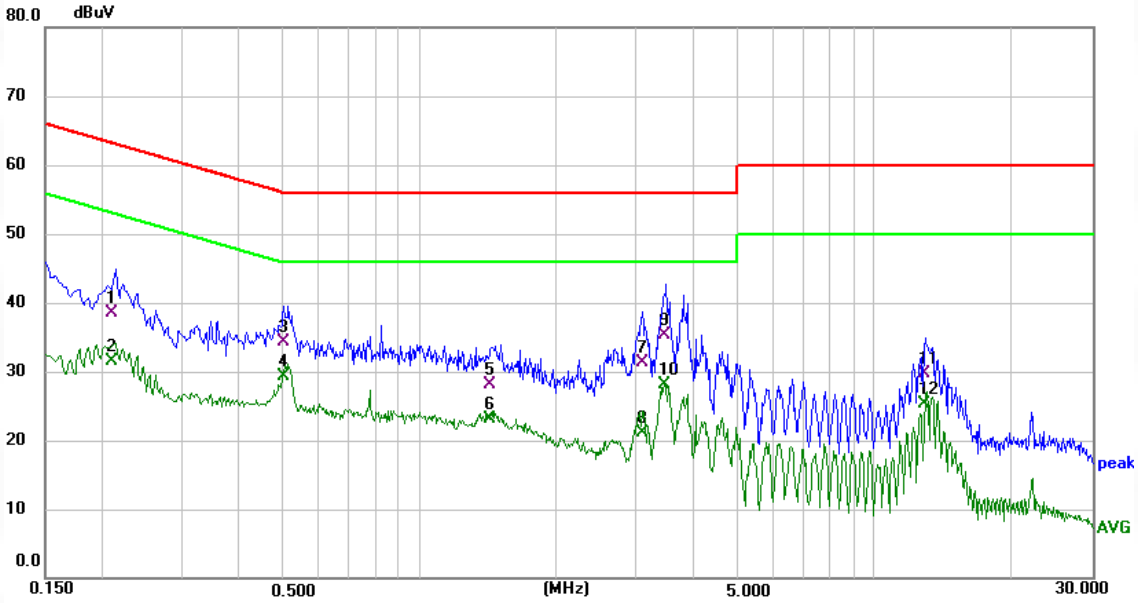
Polarity: N



No.	Frequency (MHz)	Reading Level(dBuV)	Factor (dB)	Measure-ment(dBuV)	Limit (dBuV)	Over (dB)	Detector	Comment
1	0.2100	28.97	9.52	38.49	63.21	-24.72	QP	
2	0.2100	21.94	9.52	31.46	53.21	-21.75	AVG	
3	0.5020	24.53	9.72	34.25	56.00	-21.75	QP	
4 *	0.5020	19.50	9.72	29.22	46.00	-16.78	AVG	
5	1.4220	18.23	9.94	28.17	56.00	-27.83	QP	
6	1.4220	13.22	9.94	23.16	46.00	-22.84	AVG	
7	3.0900	21.22	9.99	31.21	56.00	-24.79	QP	
8	3.0900	11.09	9.99	21.08	46.00	-24.92	AVG	
9	3.4500	25.40	9.87	35.27	56.00	-20.73	QP	
10	3.4500	18.25	9.87	28.12	46.00	-17.88	AVG	
11	12.8979	19.74	9.88	29.62	60.00	-30.38	QP	
12	12.8979	15.48	9.88	25.36	50.00	-24.64	AVG	

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6.2 Occupied Bandwidth

Test Requirement:	Intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.
Test Method:	Occupied bandwidth—relative measurement procedure
Test Limit:	Intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.
Procedure:	a) The spectrum analyzer center frequency is set to the nominal EUT channel center frequency. The span range for the EMI receiver or spectrum analyzer shall be between two times and five times the OBW. b) The nominal IF filter bandwidth (3 dB RBW) shall be in the range of 1% to 5% of the OBW and video bandwidth (VBW) shall be approximately three times RBW, unless otherwise specified by the applicable requirement. c) Set the reference level of the instrument as required, keeping the signal from exceeding the maximum input mixer level for linear operation. In general, the peak of the spectral envelope shall be more than [10 log (OBW/RBW)] below the reference level. Specific guidance is given in 4.1.5.2. d) Steps a) through c) might require iteration to adjust within the specified tolerances. e) The dynamic range of the instrument at the selected RBW shall be more than 10 dB below the target “−xx dB down” requirement; that is, if the requirement calls for measuring the −20 dB OBW, the instrument noise floor at the selected RBW shall be at least 30 dB below the reference value. f) Set detection mode to peak and trace mode to max hold. g) Determine the reference value: Set the EUT to transmit an unmodulated carrier or modulated signal, as applicable. Allow the trace to stabilize. Set the spectrum analyzer marker to the highest level of the displayed trace (this is the reference value). h) Determine the “−xx dB down amplitude” using [(reference value) − xx]. Alternatively, this calculation may be made by using the marker-delta function of the instrument. i) If the reference value is determined by an unmodulated carrier, then turn the EUT modulation ON, and either clear the existing trace or start a new trace on the spectrum analyzer and allow the new trace to stabilize. Otherwise, the trace from step g) shall be used for step j). j) Place two markers, one at the lowest frequency and the other at the highest frequency of the envelope of the spectral display, such that each marker is at or slightly below the “-xx dB down amplitude” determined in step h). If a marker is below this “−xx dB down amplitude” value, then it shall be as close as possible to this value. The occupied bandwidth is the frequency difference between the two markers. Alternatively, set a marker at the lowest frequency of the envelope of the spectral display, such that the marker is at or slightly below the “-xx dB down amplitude” determined in step h). Reset the marker-delta function and move the marker to the other side of the emission until the delta marker amplitude is at the same level as the reference marker amplitude. The marker-delta frequency reading at this point is the specified emission bandwidth.

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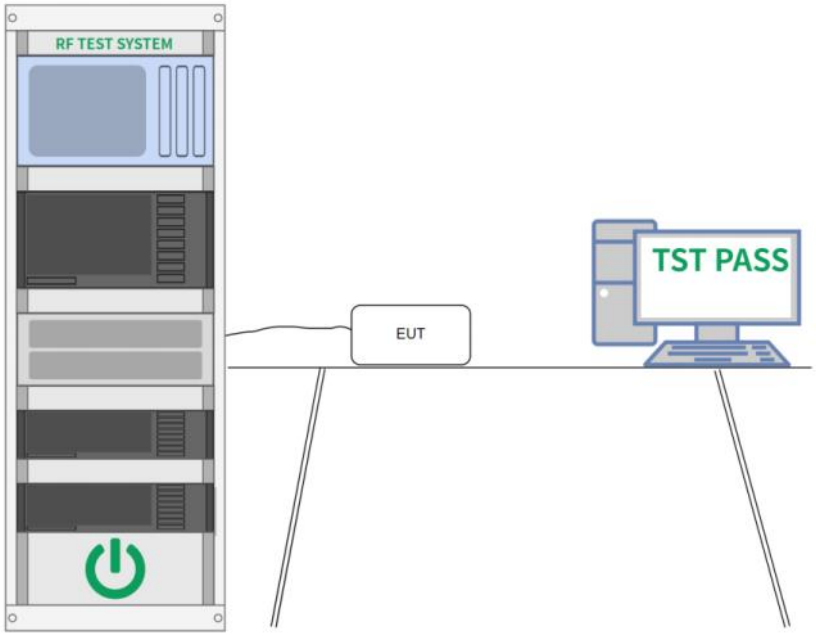
	k) The occupied bandwidth shall be reported by providing plot(s) of the measuring instrument display; the plot axes and the scale units per division shall be clearly labeled. Tabular data may be reported in addition to the plot(s).

6.2.1 E.U.T. Operation:

Operating Environment:	
Temperature:	25.6 °C
Humidity:	50.6 %
Atmospheric Pressure:	1010 mbar

6.2.2 Test Setup Diagram:



6.2.3 Test Data:

-20dB Bandwidth

Condition	Mode	Frequency (MHz)	Antenna	-20 dB Bandwidth (MHz)	Limit -20 dB Bandwidth (MHz)	Verdict
NVNT	1-DH1	2402	Ant1	0.84	N/A	Pass
NVNT	1-DH1	2441	Ant1	0.914	N/A	Pass
NVNT	1-DH1	2480	Ant1	0.848	N/A	Pass
NVNT	2-DH1	2402	Ant1	1.186	N/A	Pass
NVNT	2-DH1	2441	Ant1	1.19	N/A	Pass
NVNT	2-DH1	2480	Ant1	1.198	N/A	Pass
NVNT	3-DH1	2402	Ant1	1.192	N/A	Pass
NVNT	3-DH1	2441	Ant1	1.198	N/A	Pass
NVNT	3-DH1	2480	Ant1	1.204	N/A	Pass

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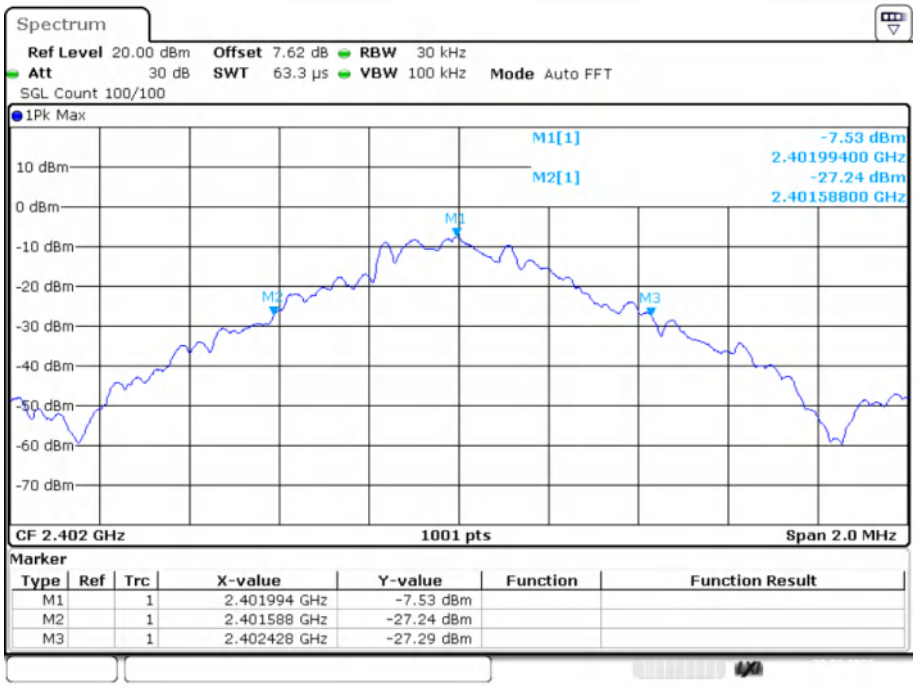
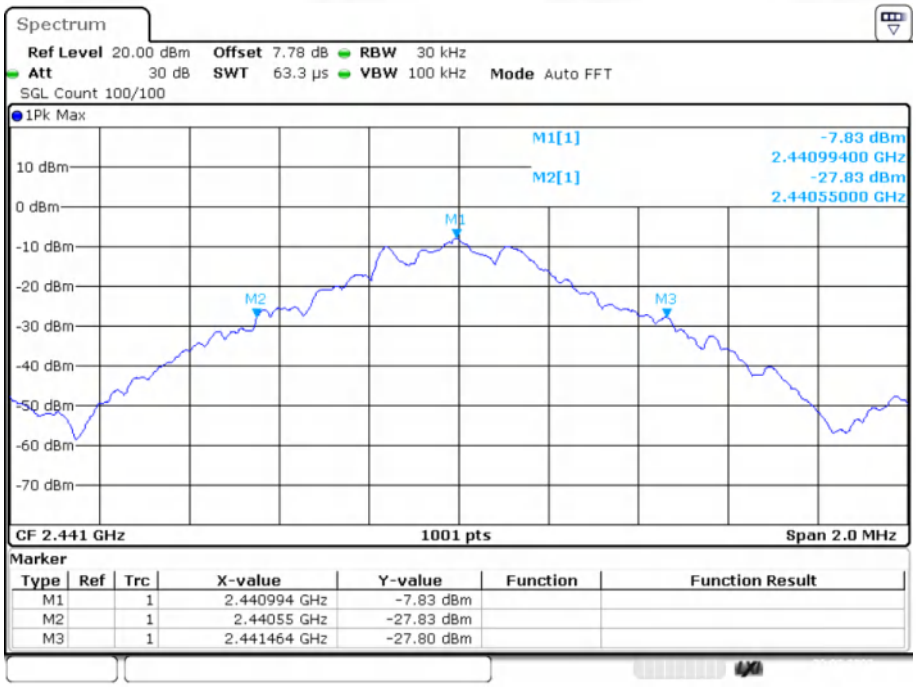
-20dB Bandwidth NVNT 1-DH1 2402MHz Ant1



-20dB Bandwidth NVNT 1-DH1 2441MHz Ant1



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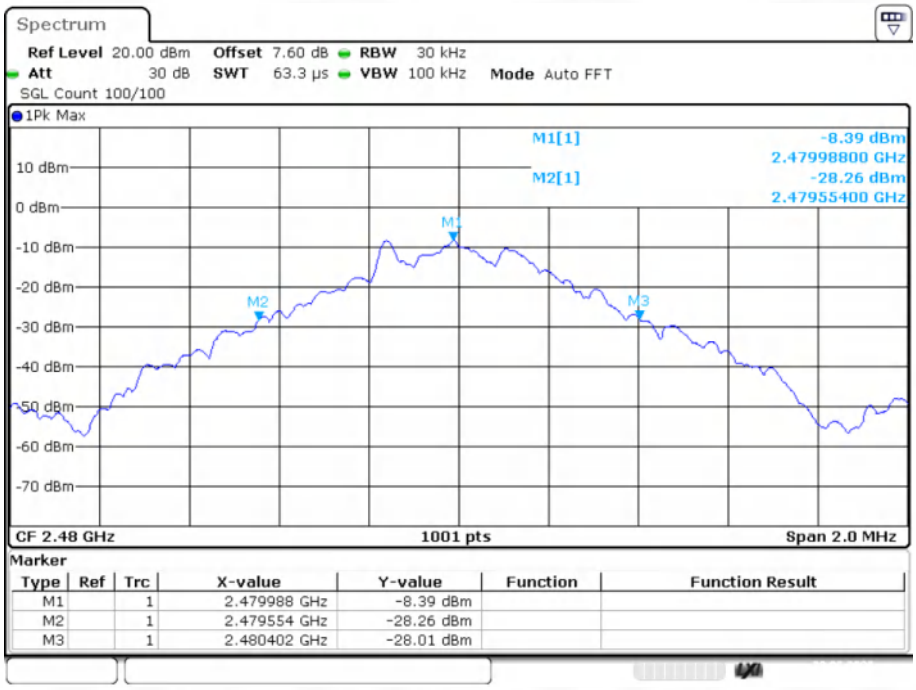
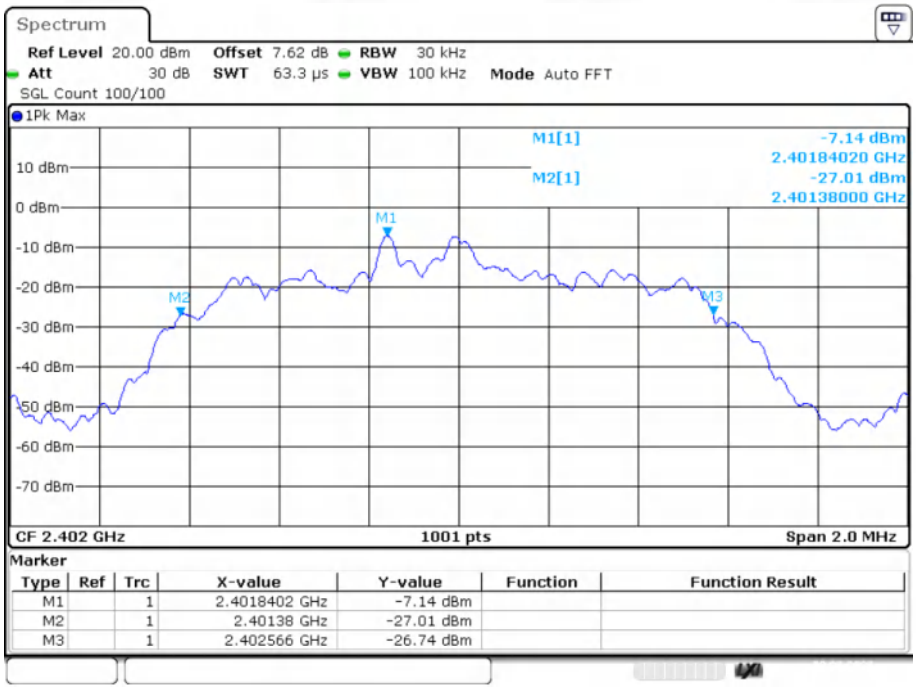
-20dB Bandwidth NVNT 1-DH1 2480MHz Ant1



-20dB Bandwidth NVNT 2-DH1 2402MHz Ant1



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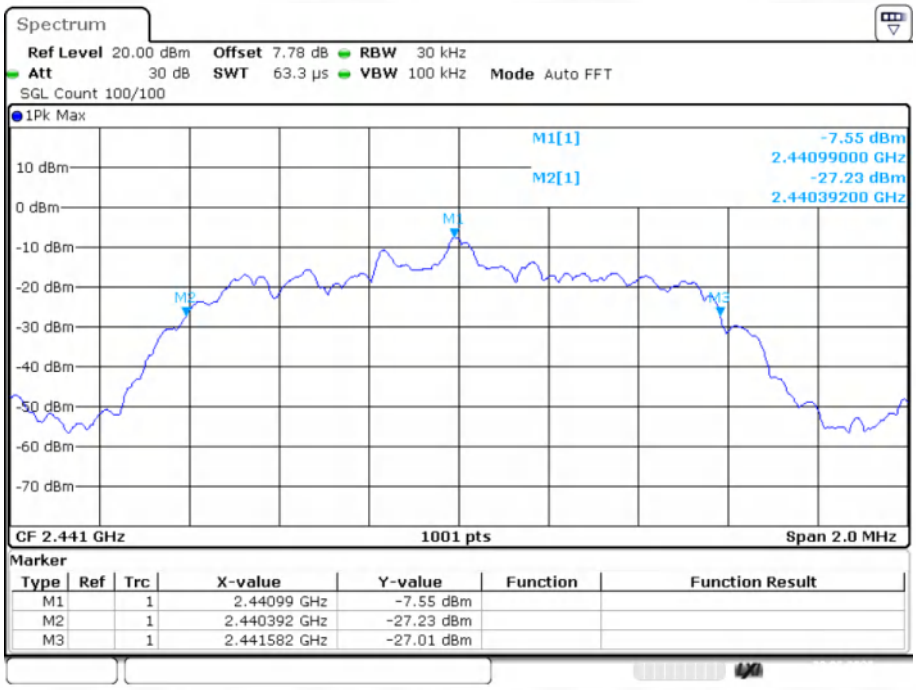
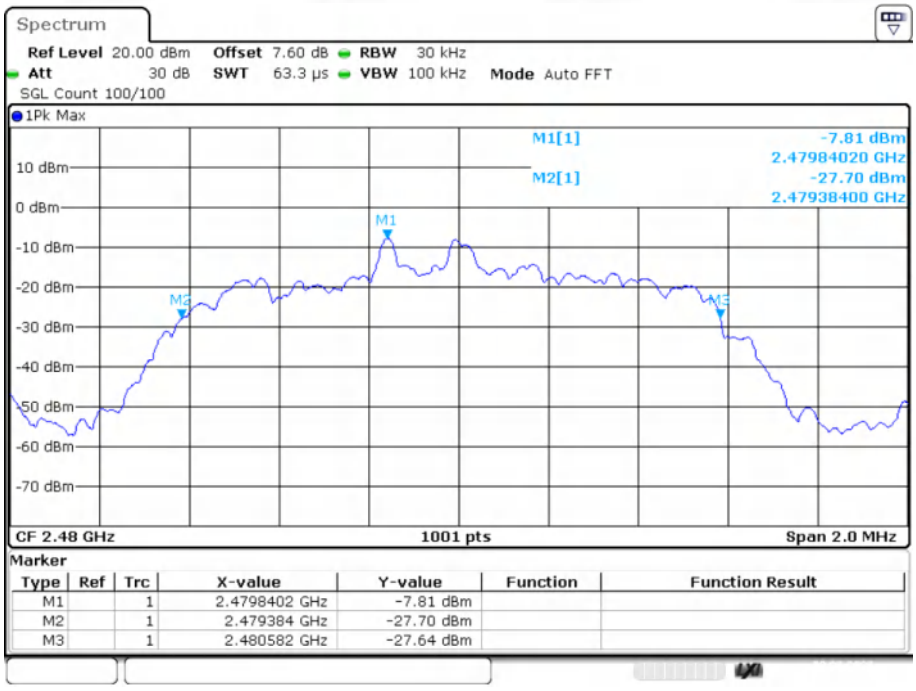
-20dB Bandwidth NVNT 2-DH1 2441MHz Ant1



-20dB Bandwidth NVNT 2-DH1 2480MHz Ant1



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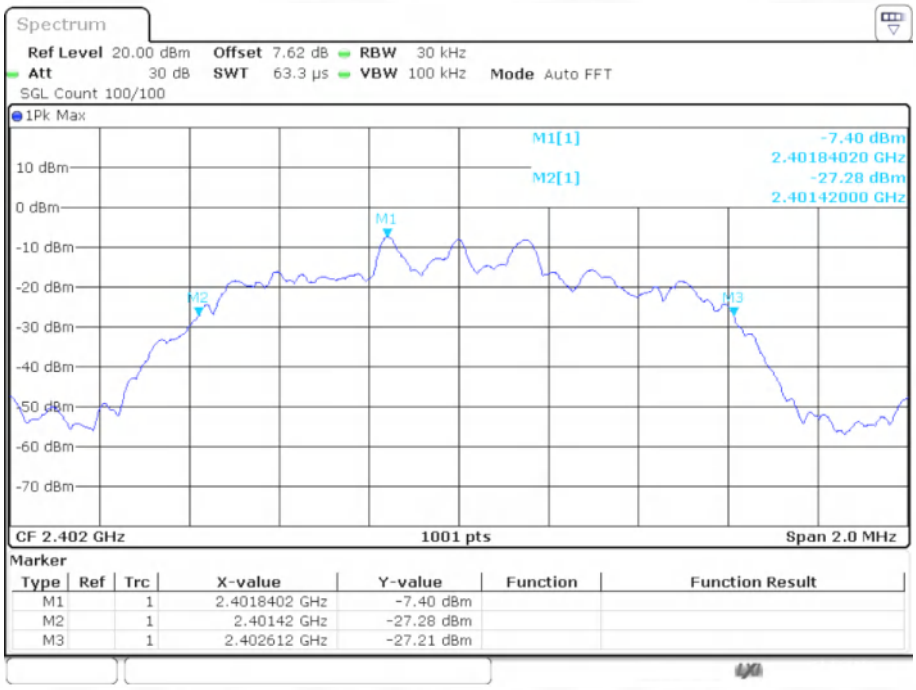
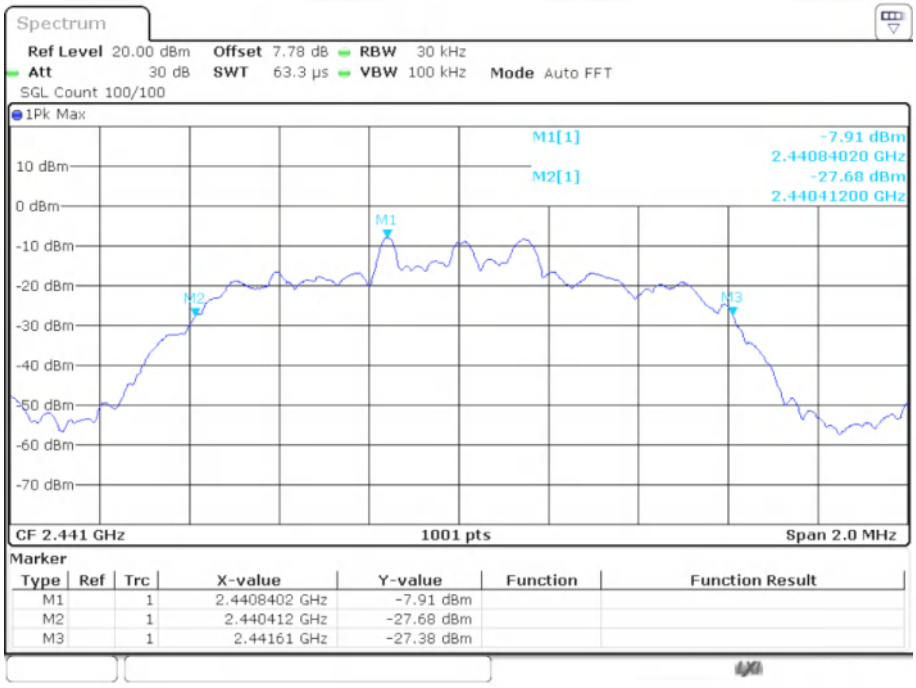
-20dB Bandwidth NVNT 3-DH1 2402MHz Ant1



-20dB Bandwidth NVNT 3-DH1 2441MHz Ant1



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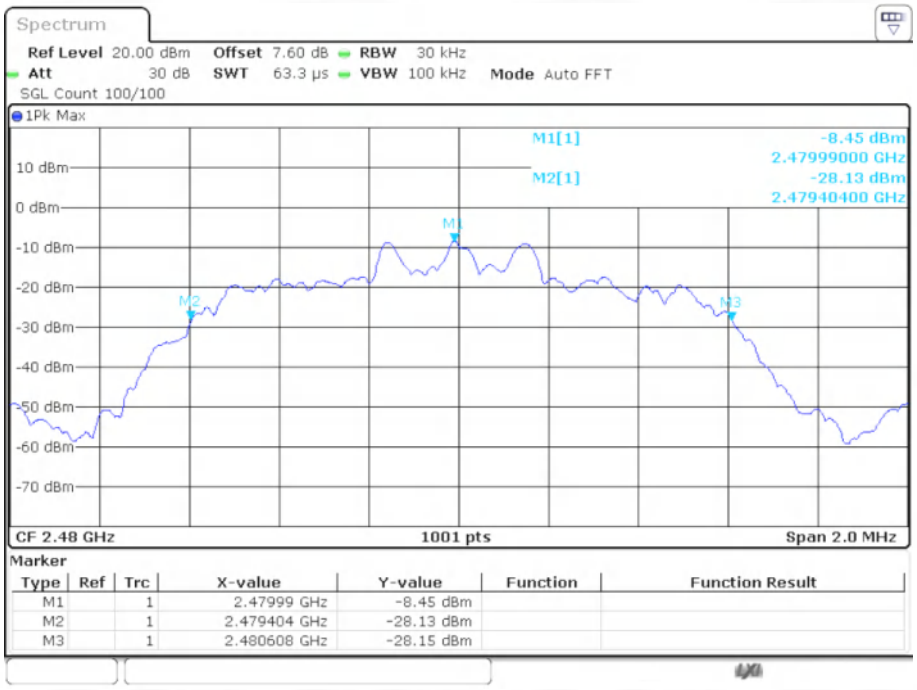
-20dB Bandwidth NVNT 3-DH1 2480MHz Ant1



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6.3 Maximum Conducted Output Power

Test Requirement:	For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.
Test Method:	Output power test procedure for frequency-hopping spread-spectrum (FHSS) devices
Test Limit:	For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.
Procedure:	This is an RF-conducted test to evaluate maximum peak output power. Use a direct connection between the antenna port of the unlicensed wireless device and the spectrum analyzer, through suitable attenuation. The hopping shall be disabled for this test: a) Use the following spectrum analyzer settings: 1) Span: Approximately five times the 20 dB bandwidth, centered on a hopping channel. 2) RBW > 20 dB bandwidth of the emission being measured. 3) VBW >= RBW. 4) Sweep: Auto. 5) Detector function: Peak. 6) Trace: Max hold. b) Allow trace to stabilize. c) Use the marker-to-peak function to set the marker to the peak of the emission. d) The indicated level is the peak output power, after any corrections for external attenuators and cables. e) A plot of the test results and setup description shall be included in the test report. NOTE—A peak responding power meter may be used, where the power meter and sensor system video bandwidth is greater than the occupied bandwidth of the unlicensed wireless device, rather than a spectrum analyzer.

6.3.1 E.U.T. Operation:

Operating Environment:	
Temperature:	25.6 °C
Humidity:	50.6 %
Atmospheric Pressure:	1010 mbar

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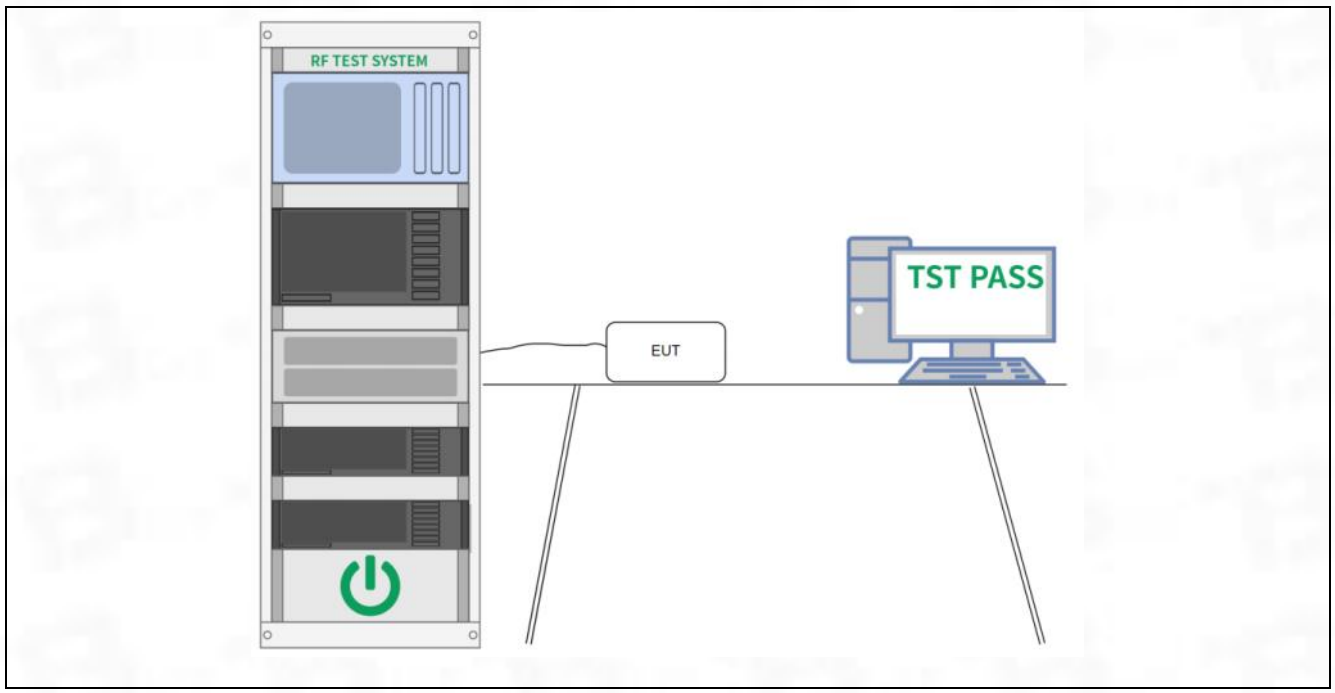
6.3.2 Test Setup Diagram:



6.3.3 Test Data:

Mode	Freq(MHz)	PK Output Power(dBm)	Limit(dBm)	Result
GFSK	2402	2.85	21	Pass
	2441	2.49	21	Pass
	2480	2.09	21	Pass
π/4 DQPSK	2402	2.46	30	Pass
	2441	2.91	30	Pass
	2480	2.51	30	Pass
8DPSK	2402	2.04	30	Pass
	2441	2.65	30	Pass
	2480	2.99	30	Pass

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6.4 Channel Separation

Test Requirement:	Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
Test Method:	Carrier frequency separation
Test Limit:	Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Wide enough to capture the peaks of two adjacent channels. b) RBW: Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel. c) Video (or average) bandwidth (VBW) ≥ RBW. d) Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. Compliance of an EUT with the appropriate regulatory limit shall be determined. A plot of the data shall be included in the test report.

6.4.1 E.U.T. Operation:

Operating Environment:	
Temperature:	25.6 °C
Humidity:	50.6 %
Atmospheric Pressure:	1010 mbar

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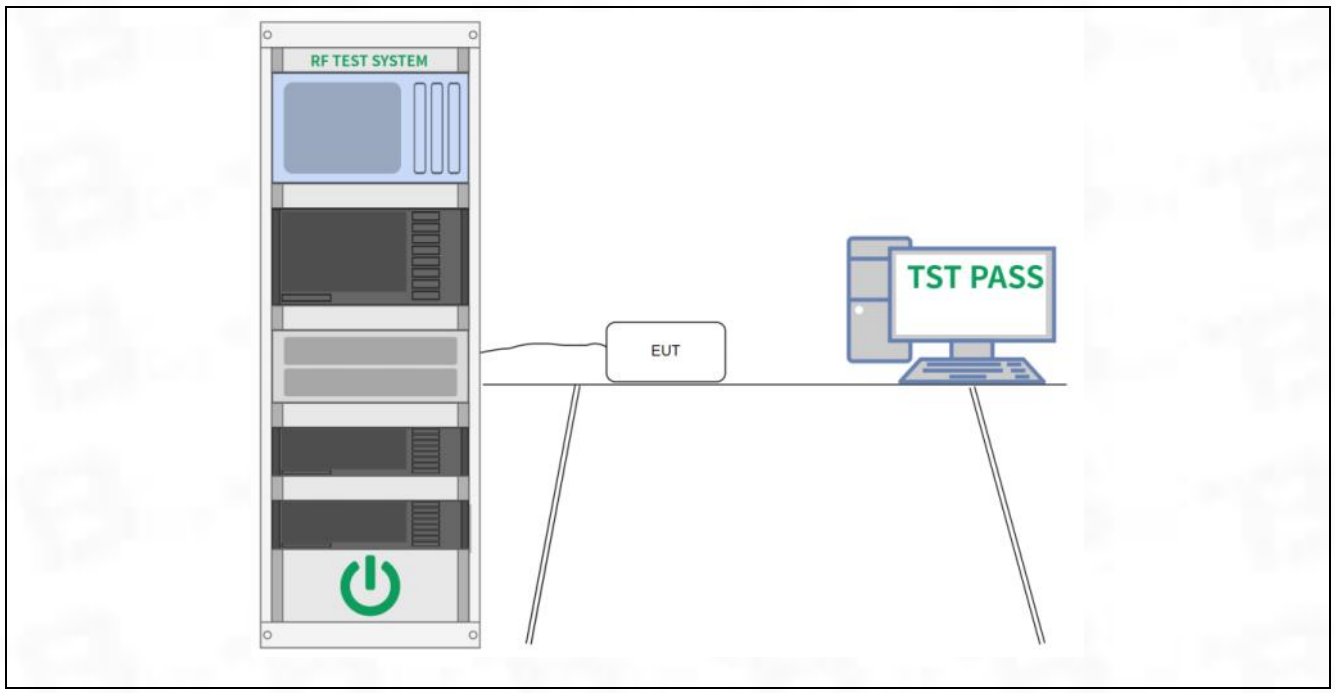
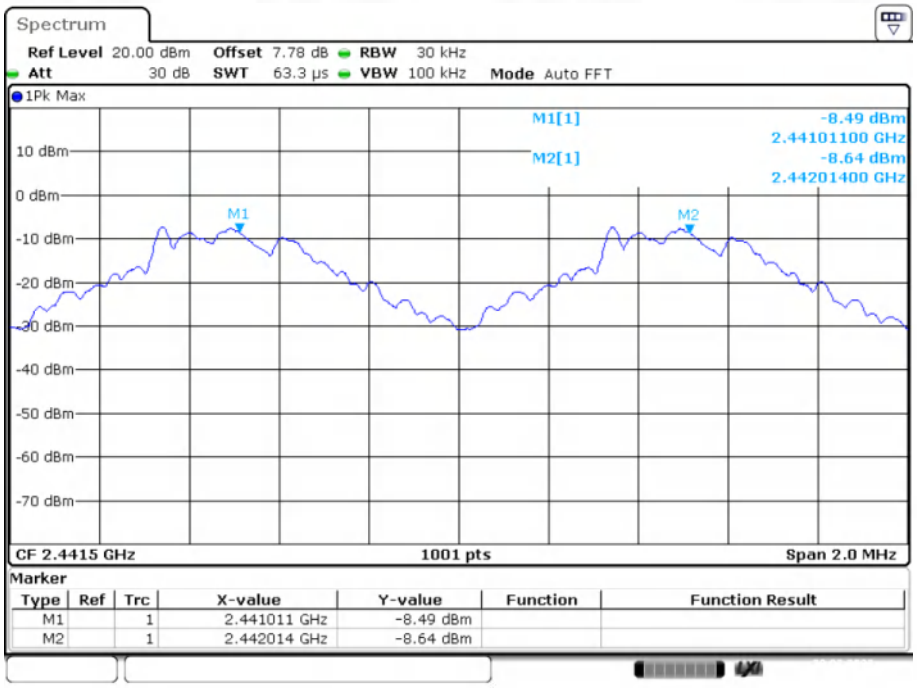
6.4.2 Test Setup Diagram:



6.4.3 Test Data:

Condition	Mode	Antenna	Hopping Freq1 (MHz)	Hopping Freq2 (MHz)	HFS (MHz)	Limit (MHz)	Verdict
NVNT	1-DH1	Ant1	2441.011	2442.014	1.003	0.914	Pass
NVNT	2-DH1	Ant1	2440.84	2441.842	1.002	0.793	Pass
NVNT	3-DH1	Ant1	2440.992	2441.992	1	0.799	Pass

CFS NVNT 1-DH1 2441MHz Ant1



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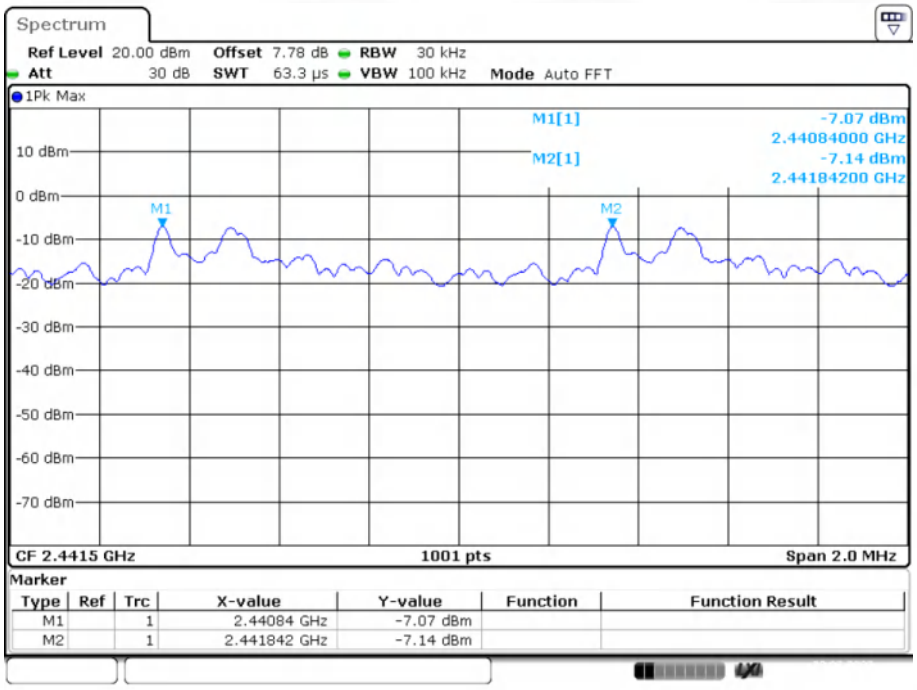
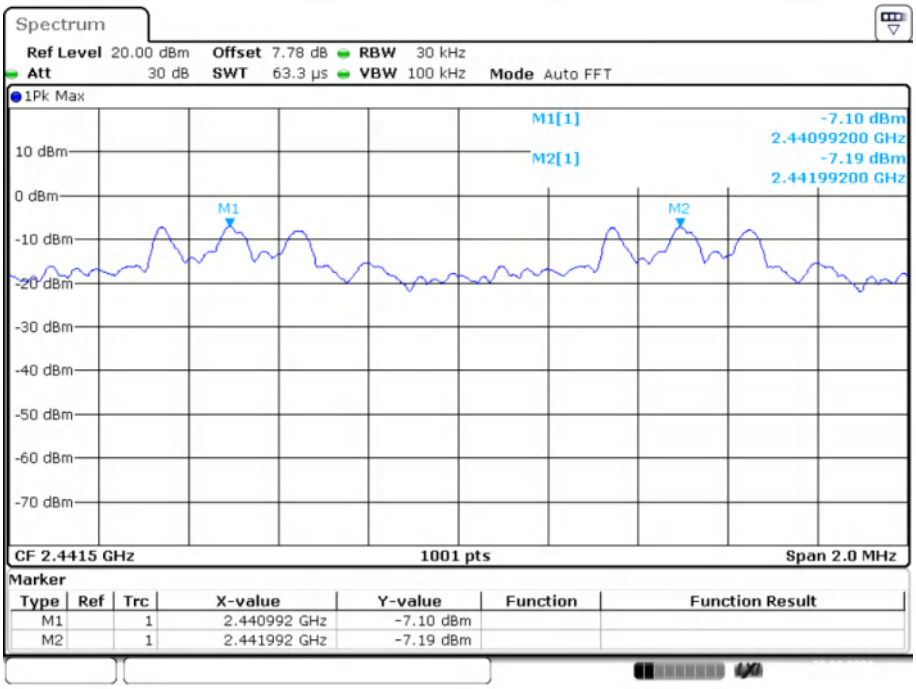
CFS NVNT 2-DH1 2441MHz Ant1



CFS NVNT 3-DH1 2441MHz Ant1



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6.5 Number of Hopping Frequencies

Test Requirement:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Method:	Number of hopping frequencies
Test Limit:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: The frequency band of operation. Depending on the number of channels the device supports, it may be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen. b) RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller. c) VBW ≥ RBW. d) Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize. It might prove necessary to break the span up into subranges to show clearly all of the hopping frequencies. Compliance of an EUT with the appropriate regulatory limit shall be determined for the number of hopping channels. A plot of the data shall be included in the test report.

6.5.1 E.U.T. Operation:

Operating Environment:	
Temperature:	25.6 °C
Humidity:	50.6 %
Atmospheric Pressure:	1010 mbar

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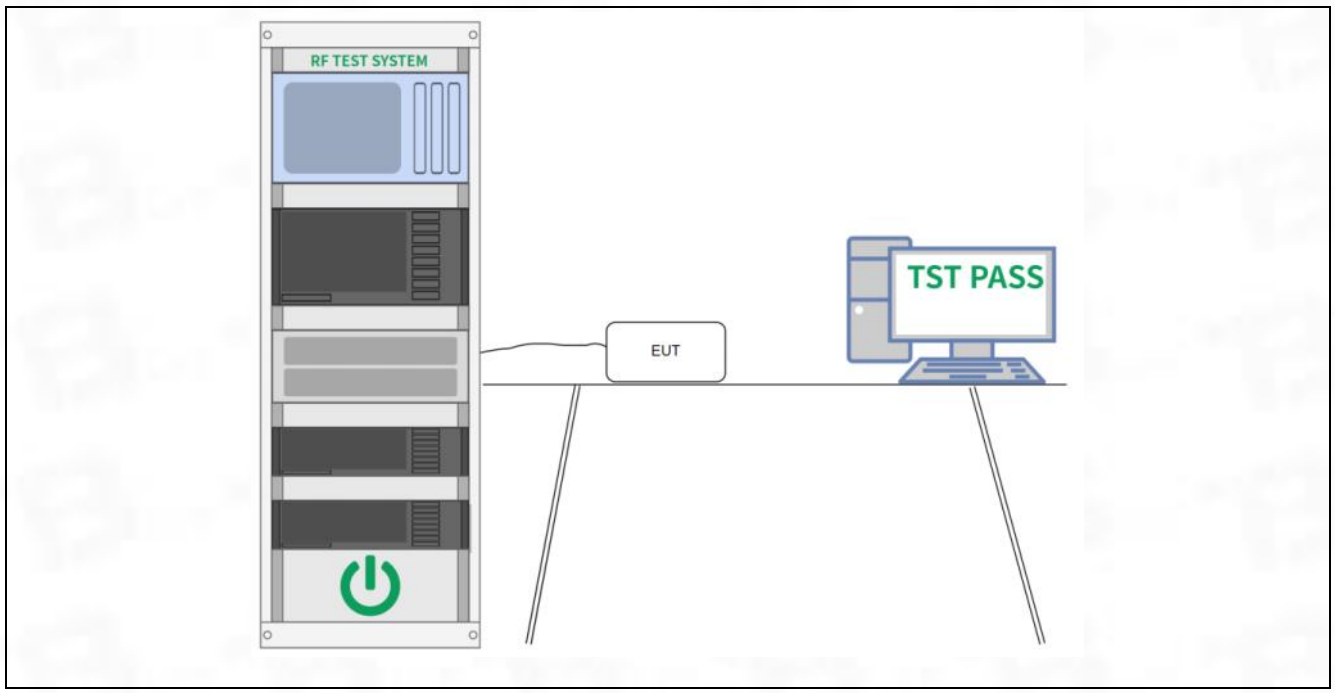
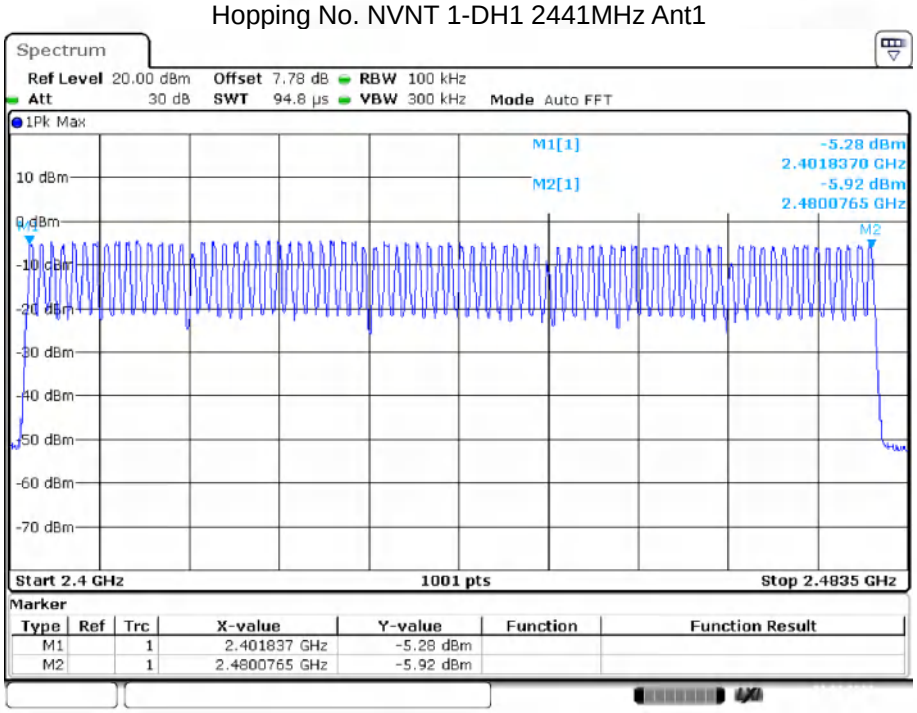
6.5.2 Test Setup Diagram:



6.5.3 Test Data:

Condition	Mode	Hopping Number	Limit	Verdict
NVNT	1-DH1	79	15	Pass
NVNT	2-DH1	79	15	Pass
NVNT	3-DH1	79	15	Pass

Hopping No. NVNT 1-DH1 2441MHz Ant1



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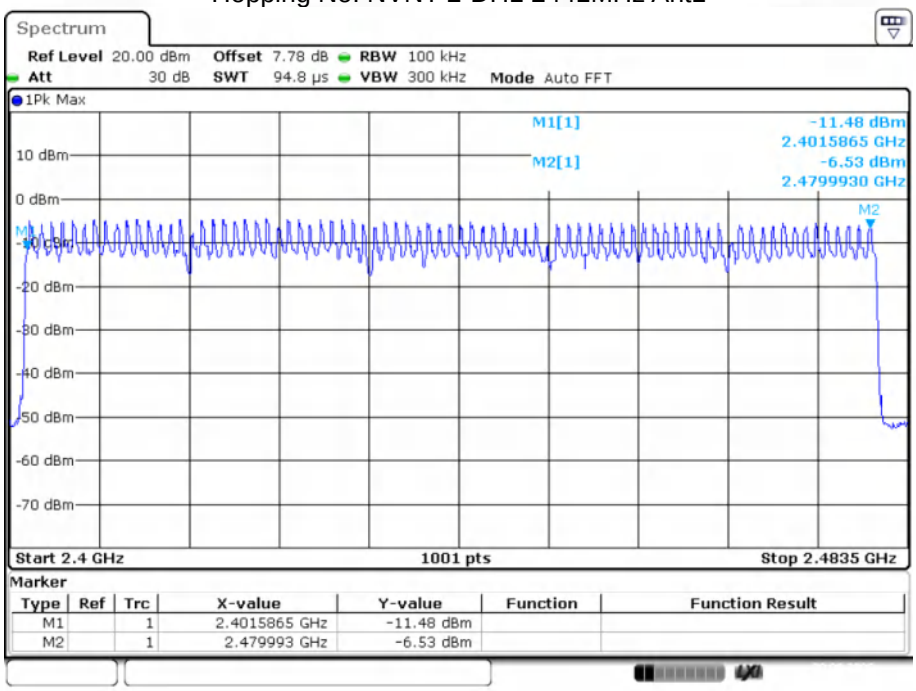
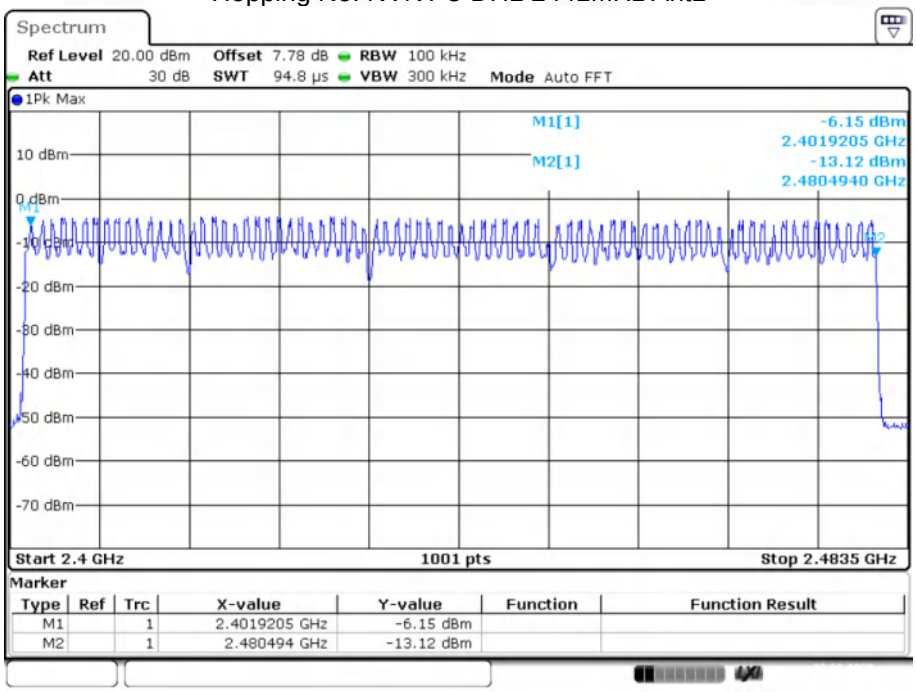
Hopping No. NVNT 2-DH1 2441MHz Ant1



Hopping No. NVNT 3-DH1 2441MHz Ant1



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6.6 Dwell Time

Test Requirement:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Method:	Time of occupancy (dwell time)
Test Limit:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Zero span, centered on a hopping channel. b) RBW shall be <= channel spacing and where possible RBW should be set >> 1 / T, where T is the expected dwell time per channel. c) Sweep: As necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel; a second plot might be needed with a longer sweep time to show two successive hops on a channel. d) Detector function: Peak. e) Trace: Max hold. Use the marker-delta function to determine the transmit time per hop. If this value varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation in transmit time. Repeat the measurement using a longer sweep time to determine the number of hops over the period specified in the requirements. The sweep time shall be equal to, or less than, the period specified in the requirements. Determine the number of hops over the sweep time and calculate the total number of hops in the period specified in the requirements, using the following equation: (Number of hops in the period specified in the requirements) = (number of hops on spectrum analyzer) × (period specified in the requirements / analyzer sweep time) The average time of occupancy is calculated from the transmit time per hop multiplied by the number of hops in the period specified in the requirements. If the number of hops in a specific time varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation. The measured transmit time and time between hops shall be consistent with the values described in the operational description for the EUT.

6.6.1 E.U.T. Operation:

Operating Environment:	
Temperature:	25.6 °C
Humidity:	50.6 %
Atmospheric Pressure:	1010 mbar

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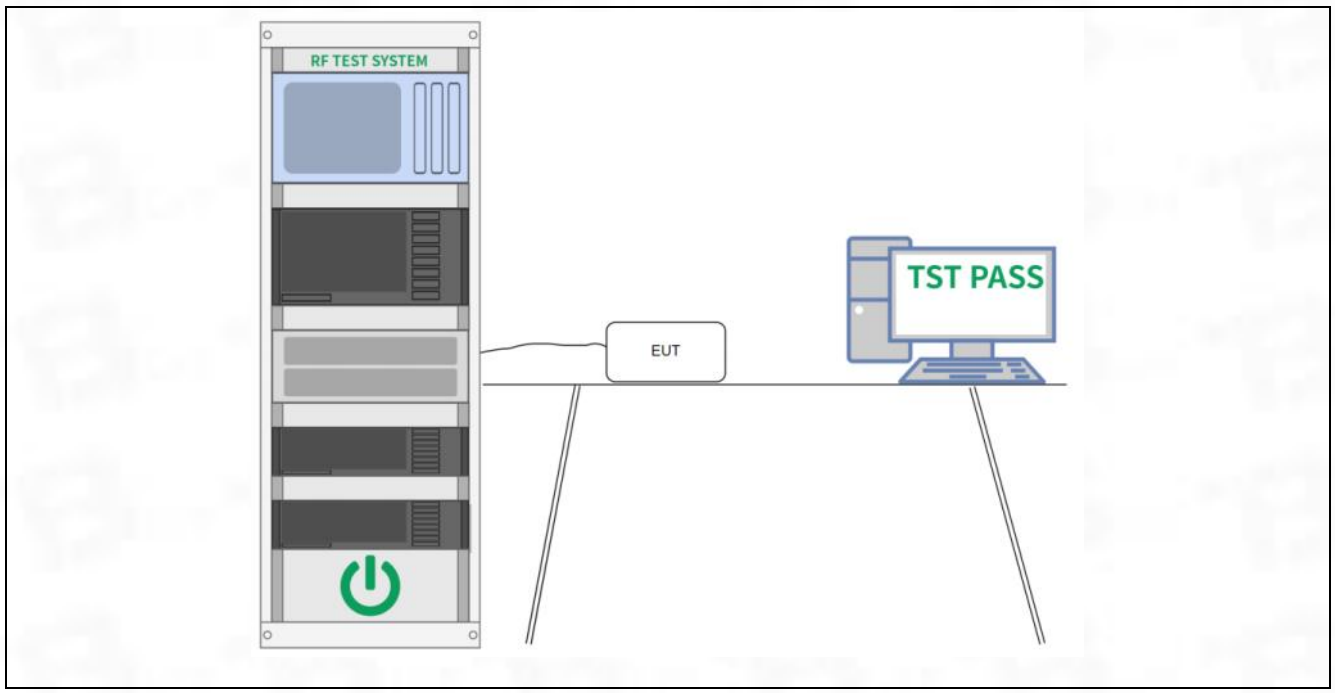
6.6.2 Test Setup Diagram:



6.6.3 Test Data:

Mode	Data Packet	Frequency (MHz)	Pulse Duration (ms)	Dwell Time (s)	Limit (s)	Conclusion
GFSK	DH1	2441	0.371	0.1187	<0.4	Pass
	DH3	2441	1.625	0.2600		Pass
	DH5	2441	2.875	0.3067		Pass
π/4 DQPSK	DH1	2441	0.395	0.1264	<0.4	Pass
	DH3	2441	1.647	0.2635		Pass
	DH5	2441	2.895	0.3088		Pass
8DPSK	DH1	2441	0.379	0.1213	<0.4	Pass
	DH3	2441	1.63	0.2608		Pass
	DH5	2441	2.88	0.3072		Pass
Note: 1 A period time = 0.4 (s) * 79 = 31.6(s) 2 DH1 time slot = Pulse Duration * (1600/(2*79)) * A period time/1000 DH3 time slot = Pulse Duration * (1600/(4*79)) * A period time/1000 DH5 time slot = Pulse Duration * (1600/(6*79)) * A period time/1000						

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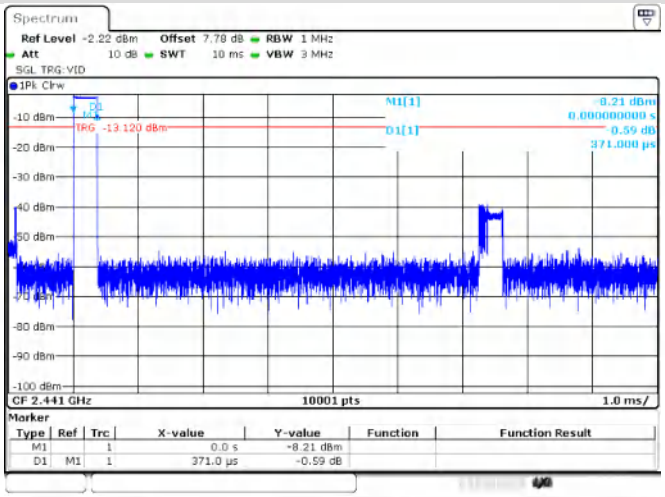
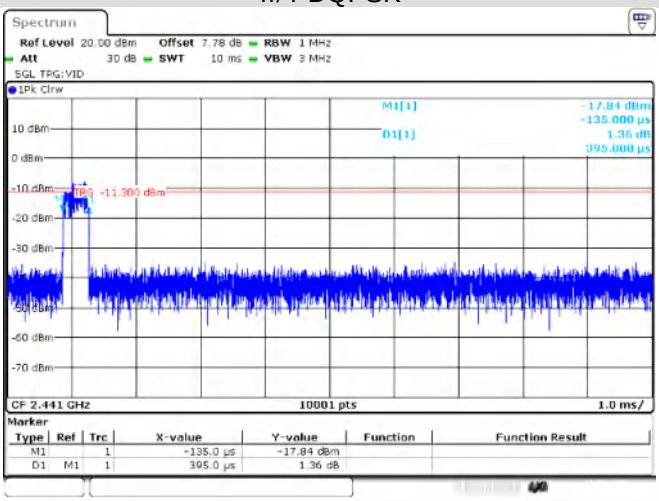
Dwell time

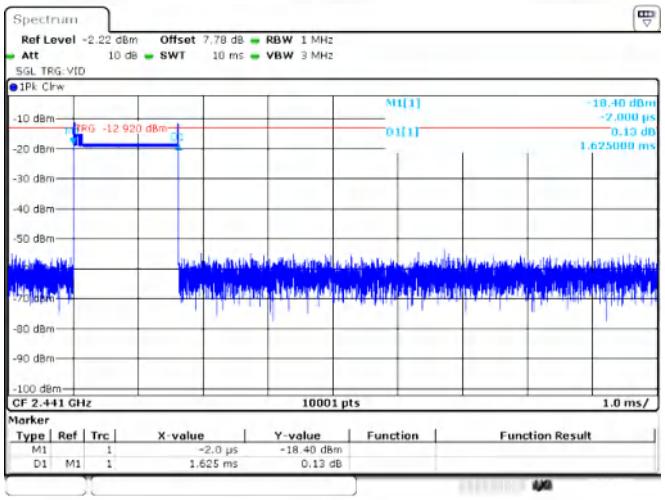
GFSK	π/4-DQPSK



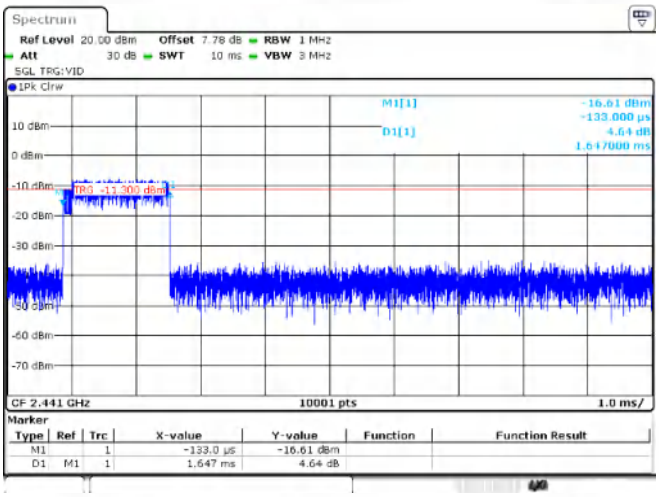
Channel 39 / 2441 MHz - DH1



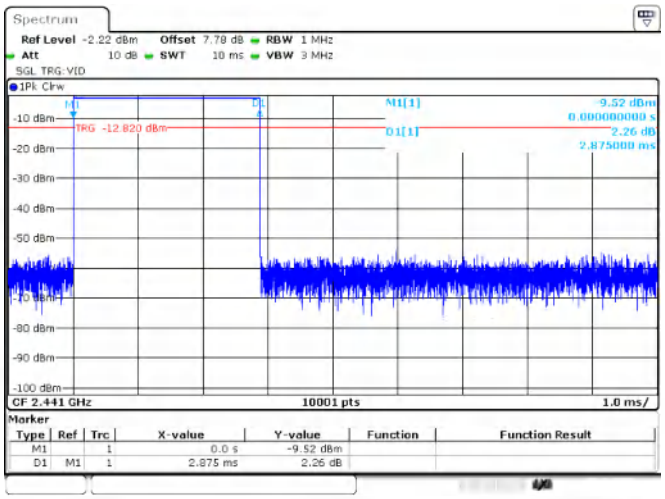
Channel 39 / 2441 MHz - 2DH1



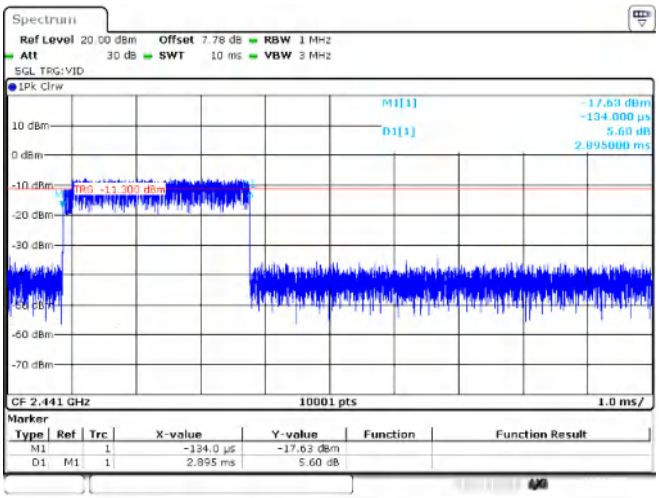
Channel 39 / 2441 MHz – DH3



Channel 39 / 2441 MHz - 2DH3



Channel 39 / 2441 MHz – DH5



Channel 39 / 2441 MHz - 2DH5

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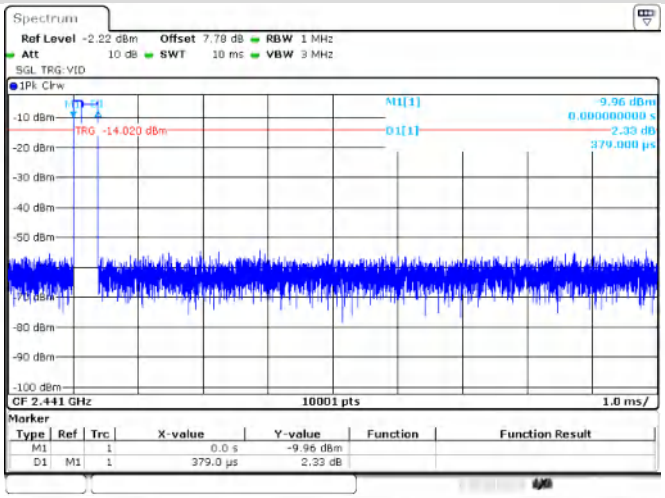
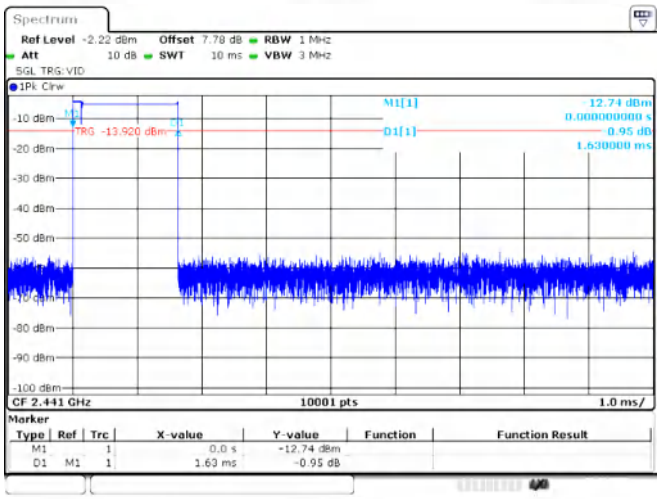
Dwell time

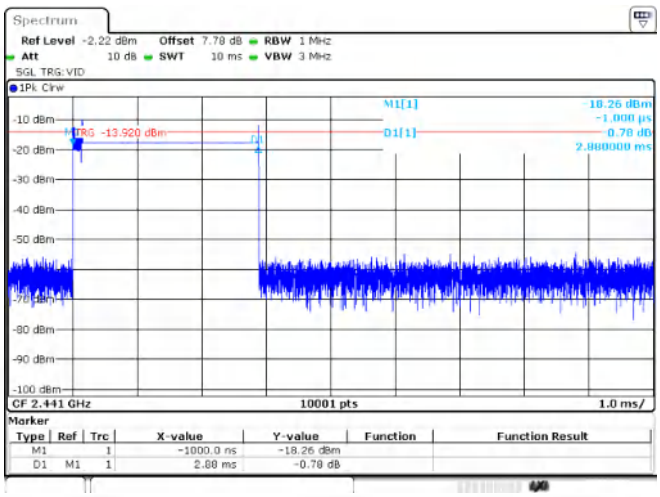
8DPSK



Channel 39 / 2441 MHz - 3DH1



Channel 39 / 2441 MHz – 3DH3



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6.7 Emissions in non-restricted frequency bands

Test Requirement:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in § 15.209(a) is not required.
Test Method:	Conducted spurious emissions test methodology
Test Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in § 15.209(a) is not required.
Procedure:	Conducted spurious emissions shall be measured for the transmit frequency, per 5.5 and 5.6, and at the maximum transmit powers. Connect the primary antenna port through an attenuator to the spectrum analyzer input; in the results, account for all losses between the unlicensed wireless device output and the spectrum analyzer. The instrument shall span 30 MHz to 10 times the operating frequency in GHz, with a resolution bandwidth of 100 kHz, video bandwidth of 300 kHz, and a coupled sweep time with a peak detector. The band 30 MHz to the highest frequency may be split into smaller spans, as long as the entire spectrum is covered.

6.7.1 E.U.T. Operation:

Operating Environment:	
Temperature:	25.6 °C
Humidity:	50.6 %
Atmospheric Pressure:	1010 mbar

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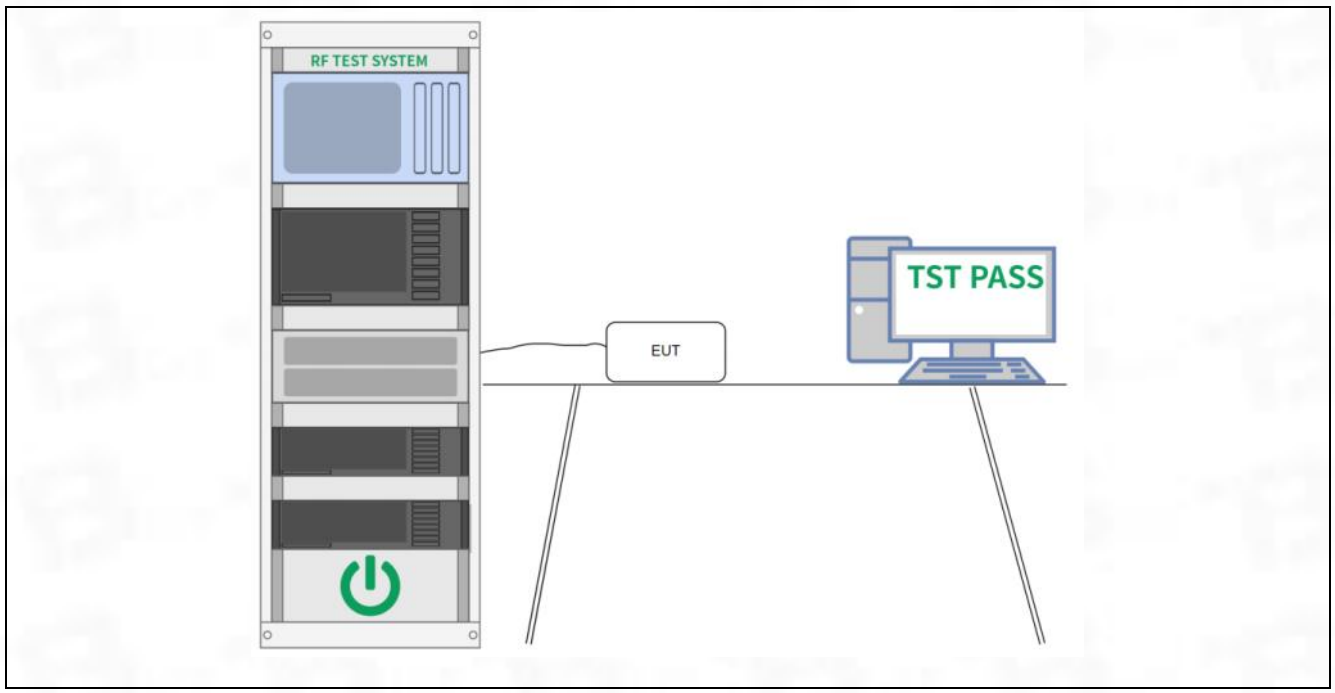
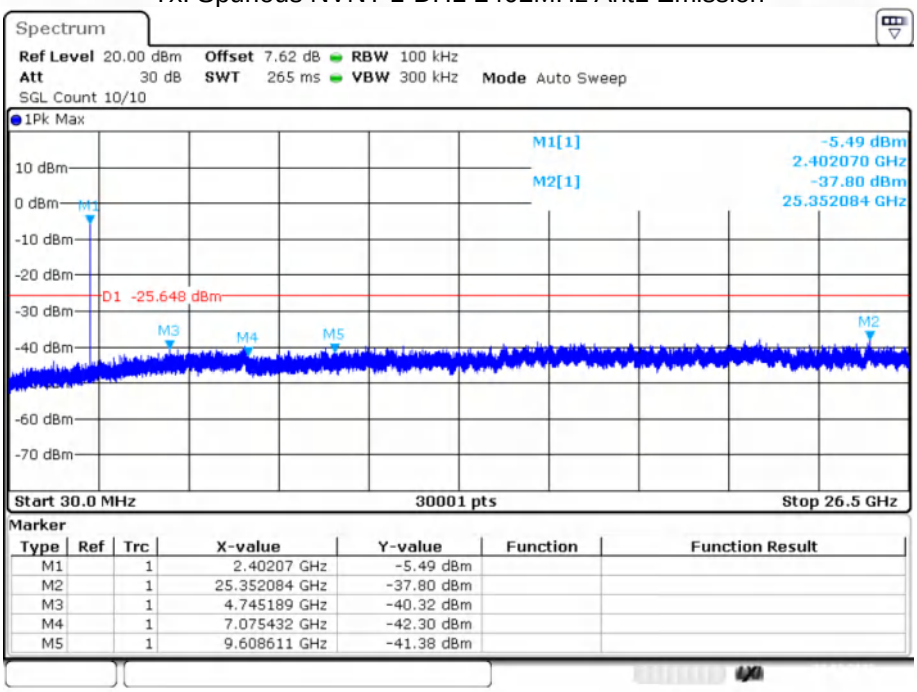
6.7.2 Test Setup Diagram:



6.7.3 Test Data:

Conducted RF Spurious Emission:

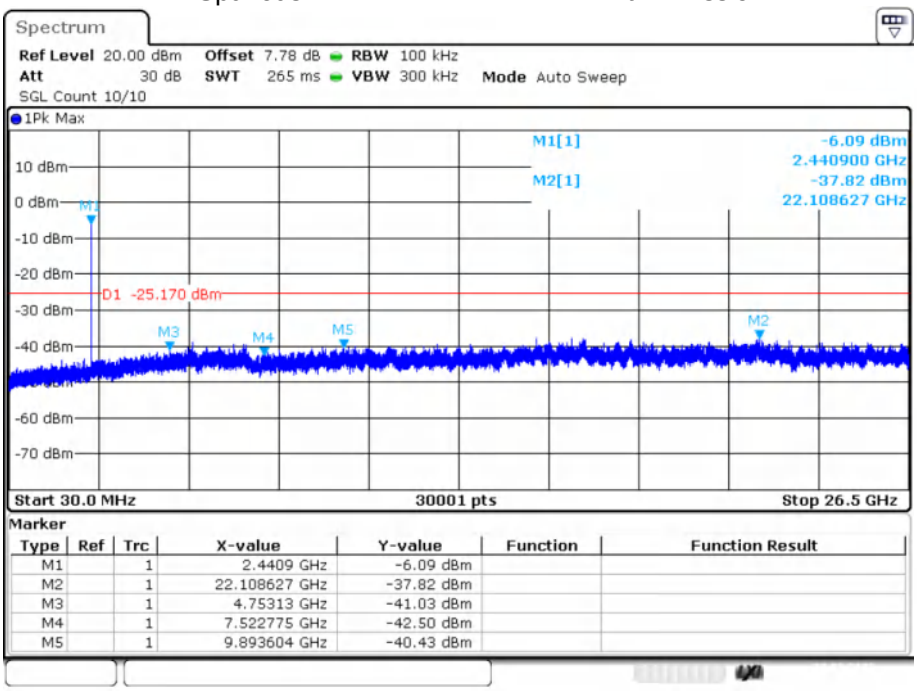
Tx. Spurious NVNT 1-DH1 2402MHz Ant1 Emission



Marker

Type	Ref	Trc	X-value	Y-value	Function	Function Result
M1		1	2.40207 GHz	-5.49 dBm		
M2		1	25.352084 GHz	-37.80 dBm		
M3		1	4.745189 GHz	-40.32 dBm		
M4		1	7.075432 GHz	-42.30 dBm		
M5		1	9.608611 GHz	-41.38 dBm		

Tx. Spurious NVNT 1-DH1 2441MHz Ant1 Emission



Marker

Type	Ref	Trc	X-value	Y-value	Function	Function Result
M1		1	2.4409 GHz	-6.09 dBm		
M2		1	22.108627 GHz	-37.82 dBm		
M3		1	4.75313 GHz	-41.03 dBm		
M4		1	7.522775 GHz	-42.50 dBm		
M5		1	9.893604 GHz	-40.43 dBm		

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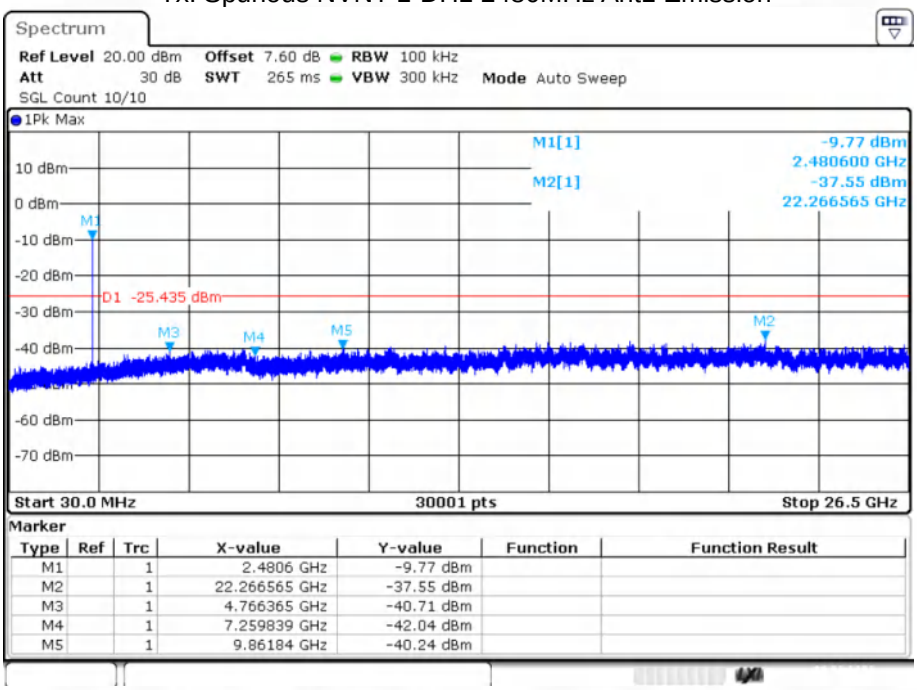
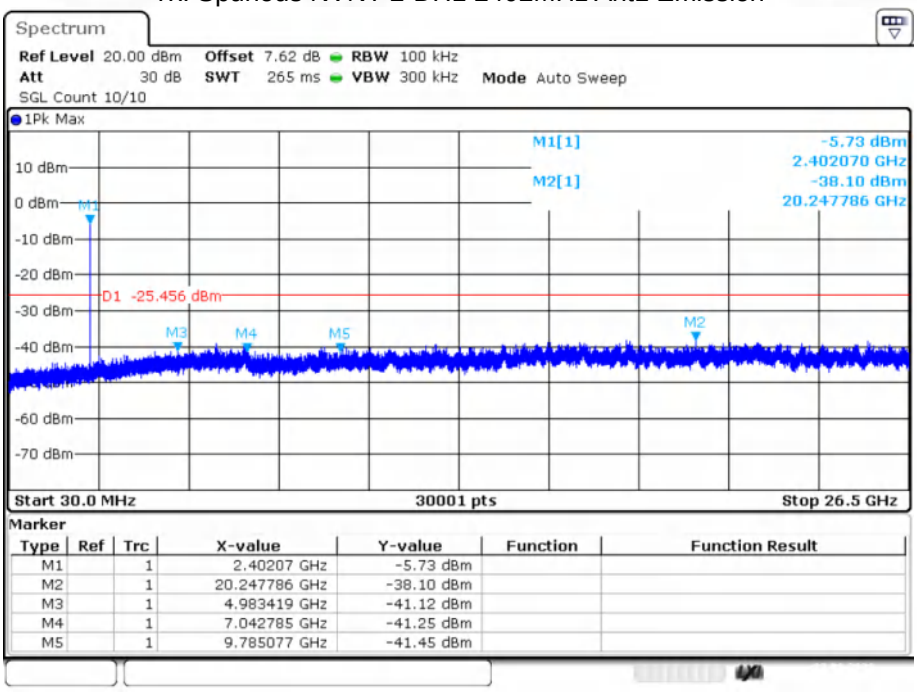
Tx. Spurious NVNT 1-DH1 2480MHz Ant1 Emission



Marker

Type	Ref	Trc	X-value	Y-value	Function	Function Result
M1		1	2.4806 GHz	-9.77 dBm		
M2		1	22.266565 GHz	-37.55 dBm		
M3		1	4.766365 GHz	-40.71 dBm		
M4		1	7.259839 GHz	-42.04 dBm		
M5		1	9.86184 GHz	-40.24 dBm		

Tx. Spurious NVNT 2-DH1 2402MHz Ant1 Emission



Marker

Type	Ref	Trc	X-value	Y-value	Function	Function Result
M1		1	2.40207 GHz	-5.73 dBm		
M2		1	20.247786 GHz	-38.10 dBm		
M3		1	4.983419 GHz	-41.12 dBm		
M4		1	7.042785 GHz	-41.25 dBm		
M5		1	9.785077 GHz	-41.45 dBm		

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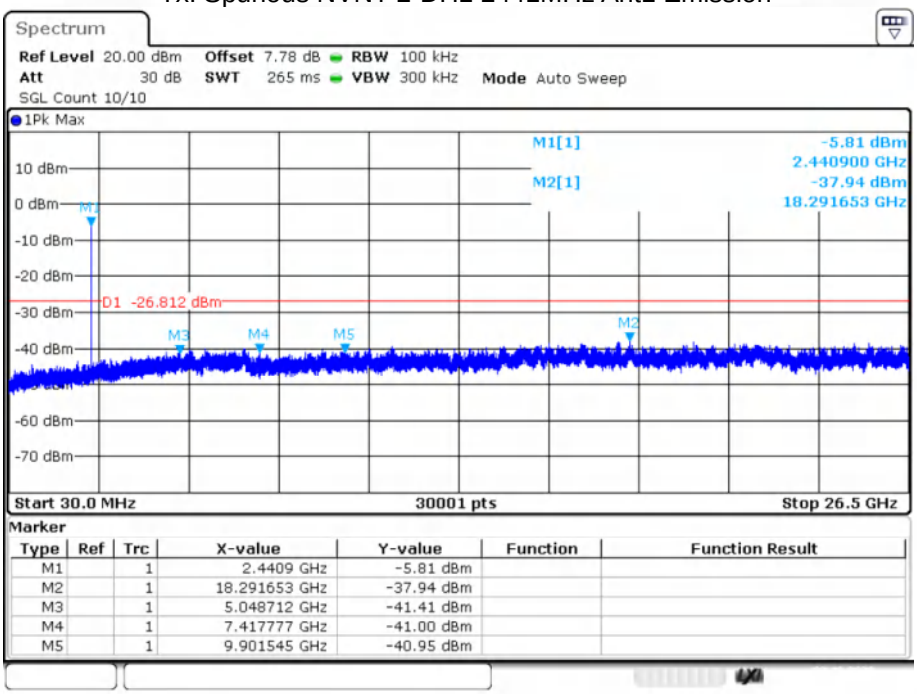
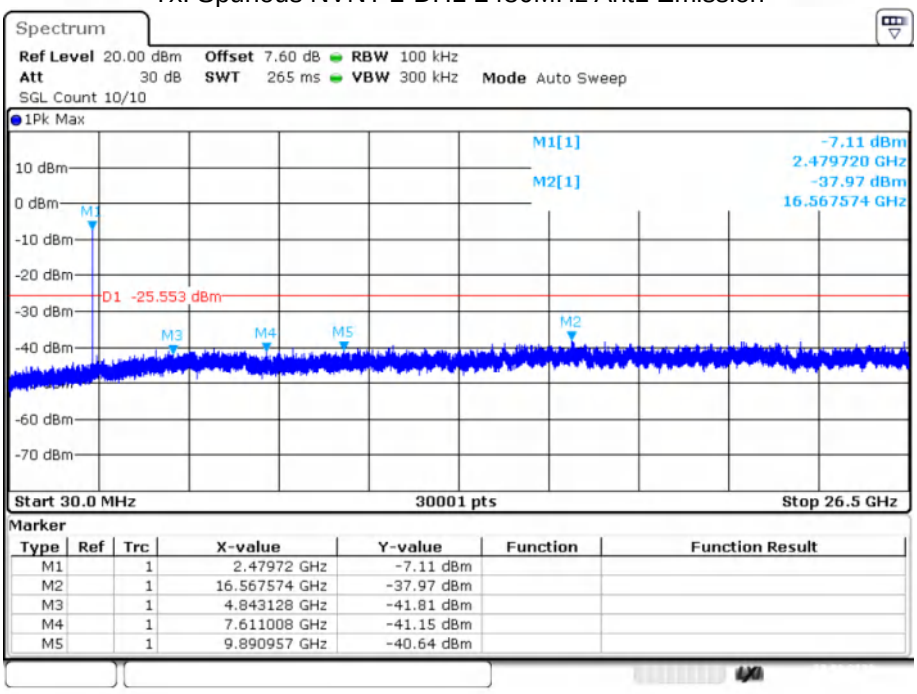
Tx. Spurious NVNT 2-DH1 2441MHz Ant1 Emission



Marker

Type	Ref	Trc	X-value	Y-value	Function	Function Result
M1		1	2.4409 GHz	-5.81 dBm		
M2		1	18.291653 GHz	-37.94 dBm		
M3		1	5.048712 GHz	-41.41 dBm		
M4		1	7.417777 GHz	-41.00 dBm		
M5		1	9.901545 GHz	-40.95 dBm		

Tx. Spurious NVNT 2-DH1 2480MHz Ant1 Emission



Marker

Type	Ref	Trc	X-value	Y-value	Function	Function Result
M1		1	2.47972 GHz	-7.11 dBm		
M2		1	16.567574 GHz	-37.97 dBm		
M3		1	4.843128 GHz	-41.81 dBm		
M4		1	7.611008 GHz	-41.15 dBm		
M5		1	9.890957 GHz	-40.64 dBm		

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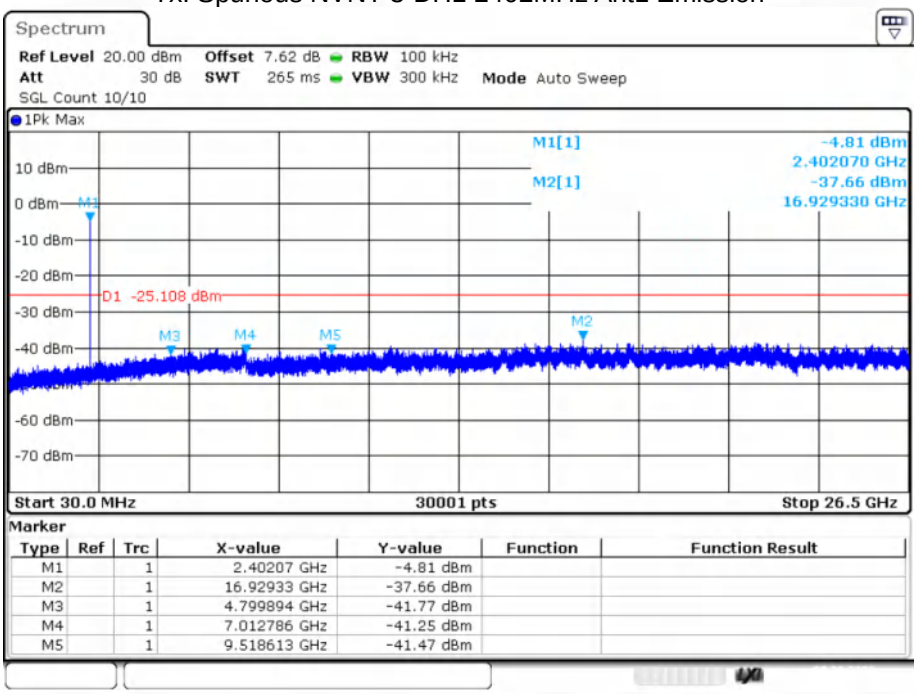
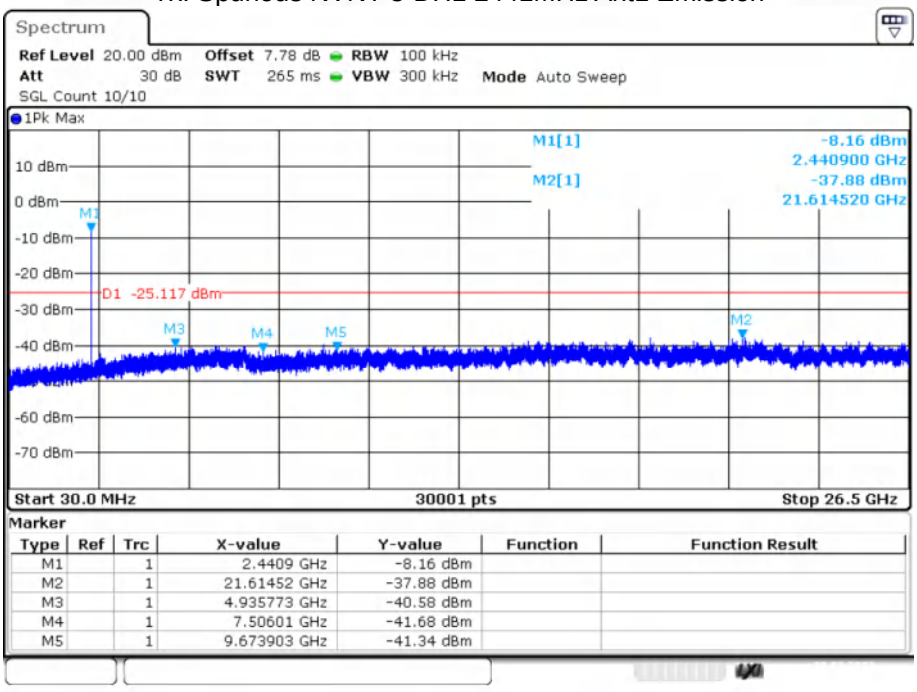
Tx. Spurious NVNT 3-DH1 2402MHz Ant1 Emission



Marker

Type	Ref	Trc	X-value	Y-value	Function	Function Result
M1		1	2.40207 GHz	-4.81 dBm		
M2		1	16.92933 GHz	-37.66 dBm		
M3		1	4.799894 GHz	-41.77 dBm		
M4		1	7.012786 GHz	-41.25 dBm		
M5		1	9.518613 GHz	-41.47 dBm		

Tx. Spurious NVNT 3-DH1 2441MHz Ant1 Emission



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Type	Ref	Trc	X-value	Y-value	Function	Function Result
M1		1	2.4409 GHz	-8.16 dBm		
M2		1	21.61452 GHz	-37.88 dBm		
M3		1	4.935773 GHz	-40.58 dBm		
M4		1	7.50601 GHz	-41.68 dBm		
M5		1	9.673903 GHz	-41.34 dBm		

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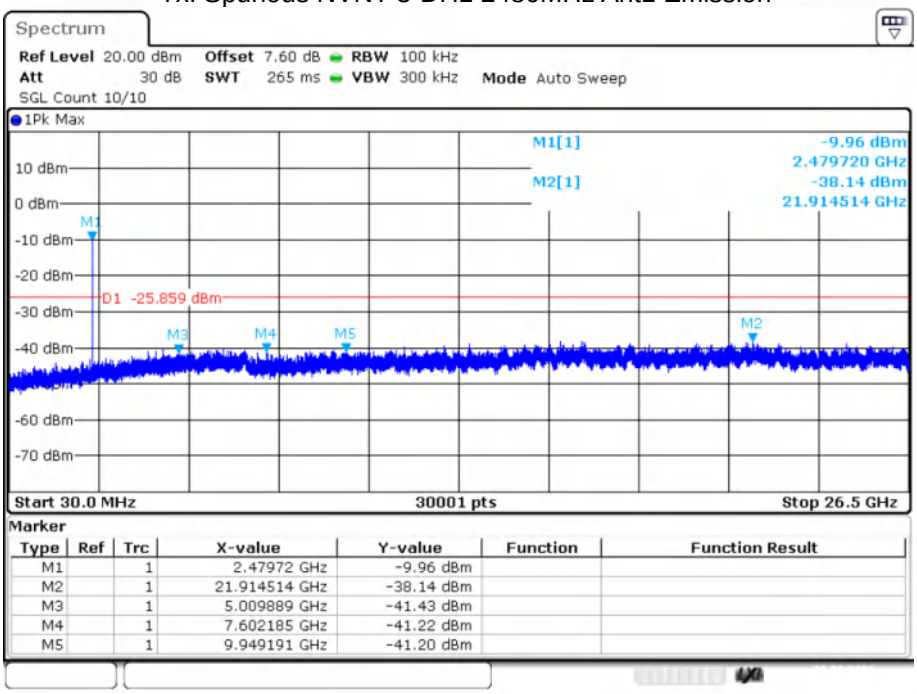
Tx. Spurious NVNT 3-DH1 2480MHz Ant1 Emission



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Type	Ref	Trc	X-value	Y-value	Function	Function Result
M1		1	2.47972 GHz	-9.96 dBm		
M2		1	21.914514 GHz	-38.14 dBm		
M3		1	5.009889 GHz	-41.43 dBm		
M4		1	7.602185 GHz	-41.22 dBm		
M5		1	9.949191 GHz	-41.20 dBm		

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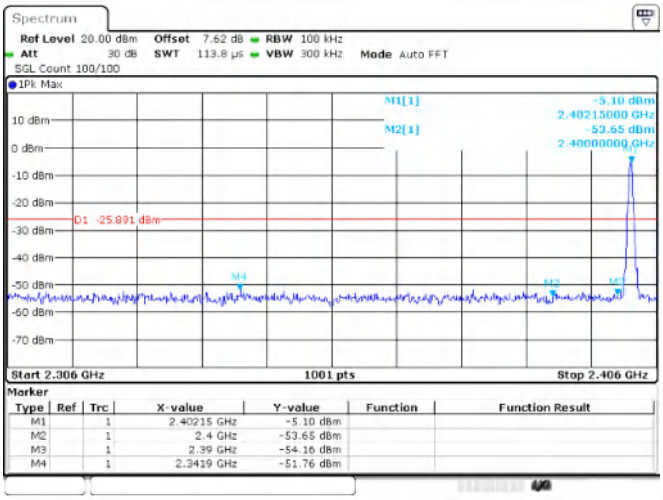
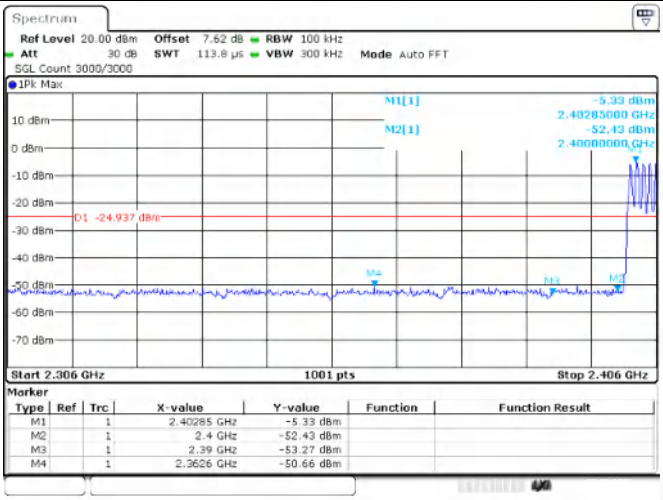
Test channel:	Lowest channel

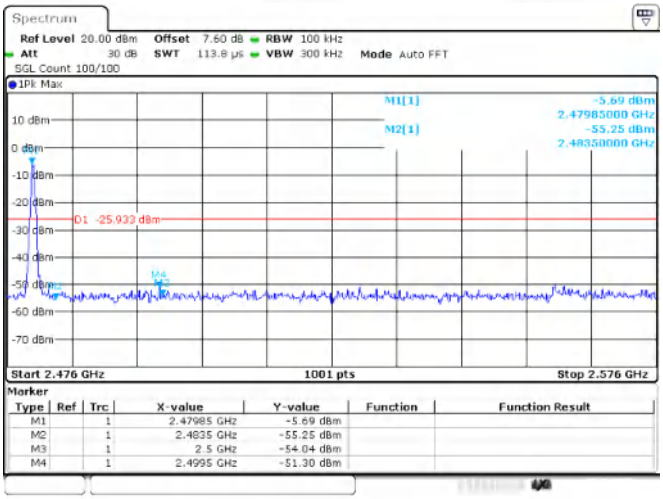


No-hopping mode

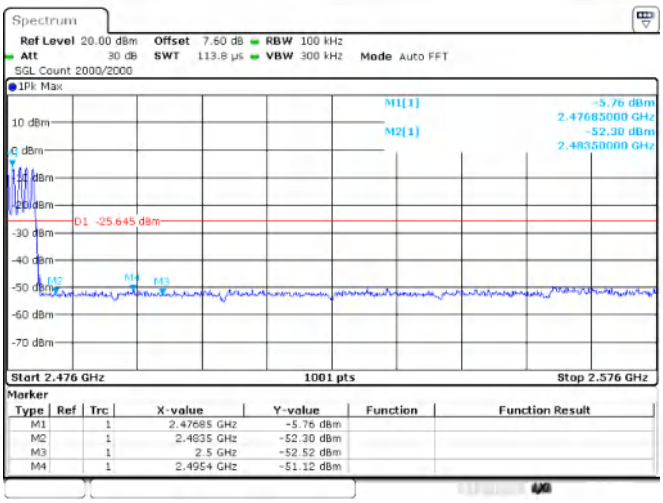


Hopping mode

Test channel:	Highest channel



No-hopping mode



Hopping mode

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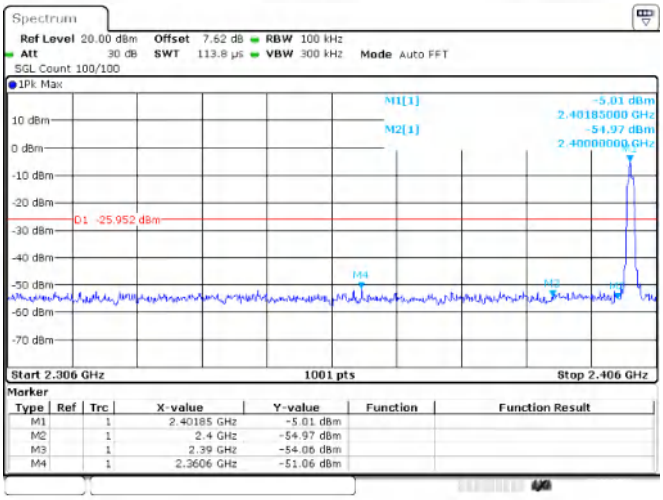
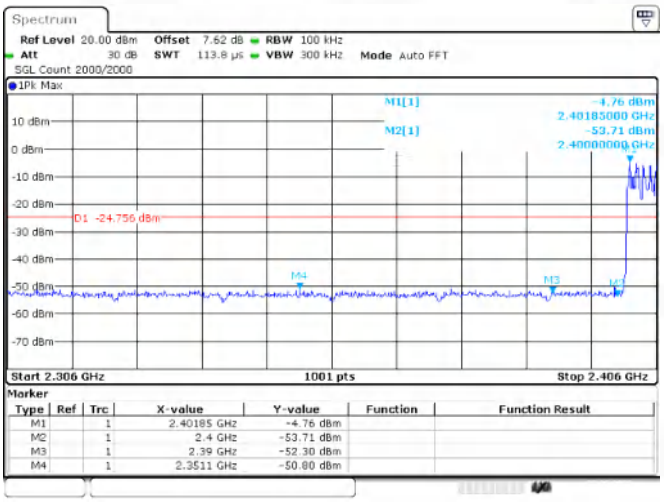
π/4DQPSK Mode:

Test channel:	Lowest channel

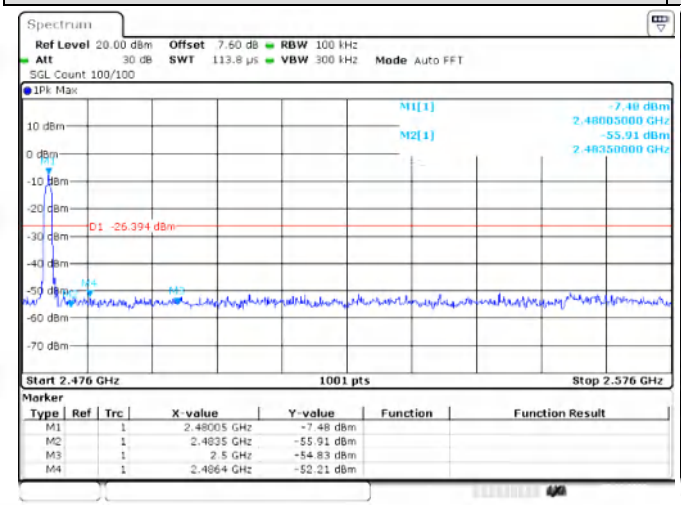


No-hopping mode

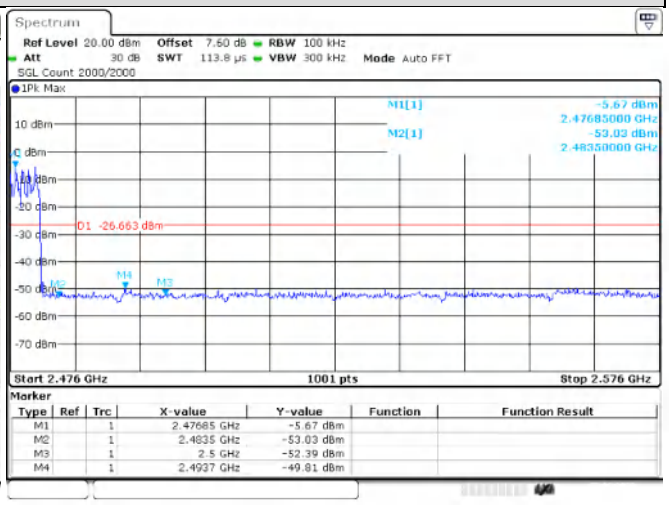


Hopping mode

Test channel:	Highest channel



No-hopping mode



Hopping mode

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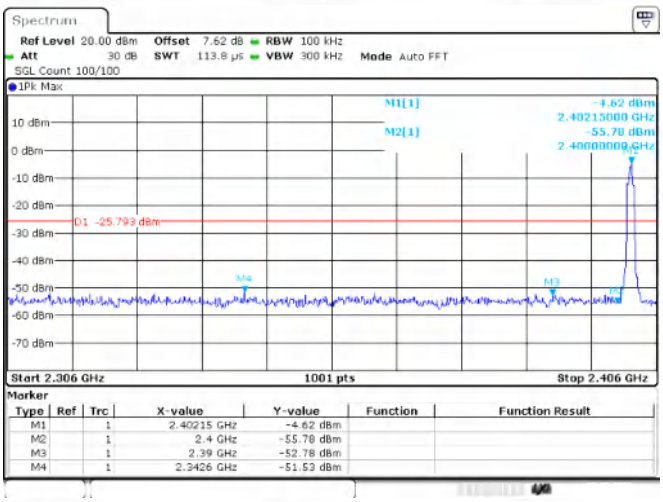
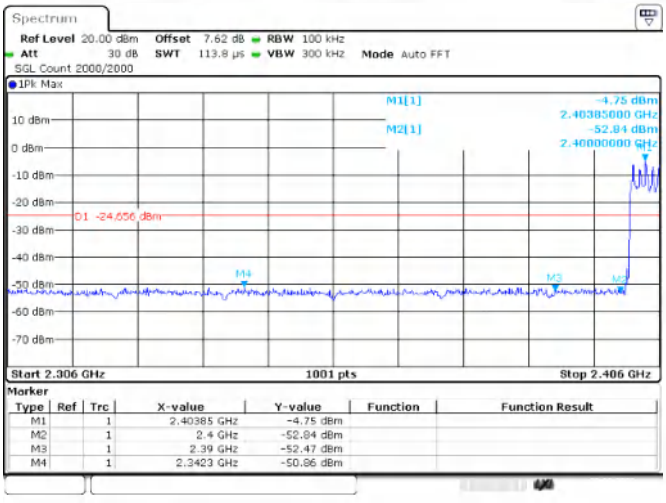
8DPSK Mode:

Test channel:	Lowest channel

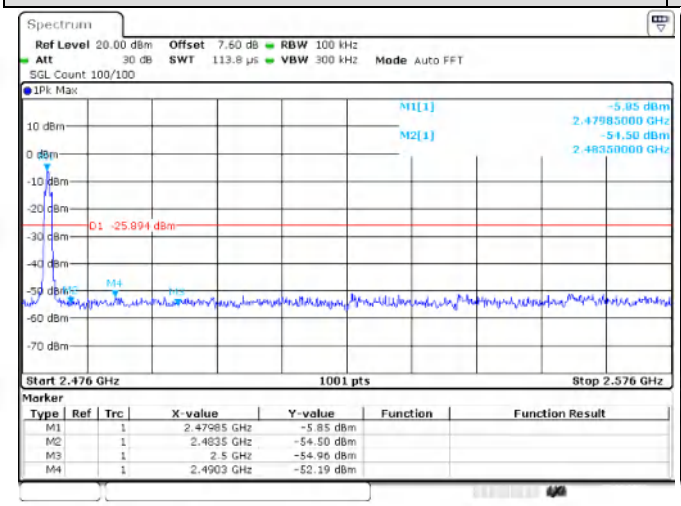


No-hopping mode

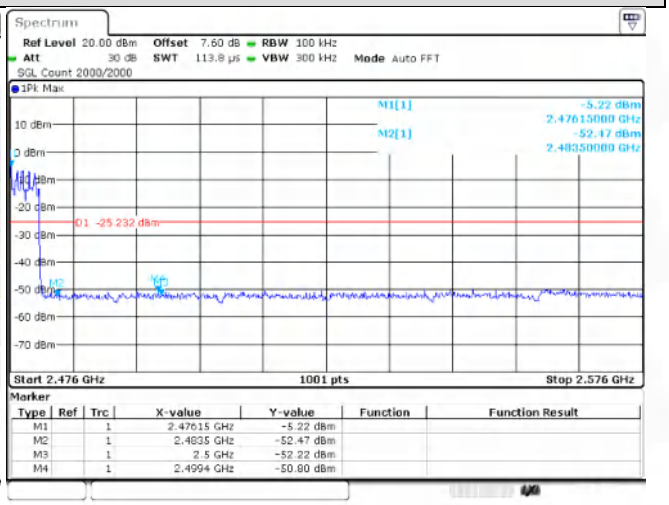


Hopping mode

Test channel:	Highest channel



No-hopping mode



Hopping mode

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6.8 Band edge emissions (Radiated)

<table>
<tr><td>Test Requirement:</td><td>In addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § 15.209(a)(see § 15.205(c)).`</td></tr>
<tr><td>Test Method:</td><td>Radiated emissions tests</td></tr>
<tr><td>Test Limit:</td><td>
<table>
<tr><td>Frequency (MHz)</td><td>Field strength (microvolts/meter)</td><td>Measurement distance (meters)</td></tr>
<tr><td>0.009-0.490</td><td>2400/F(kHz)</td><td>300</td></tr>
<tr><td>0.490-1.705</td><td>24000/F(kHz)</td><td>30</td></tr>
<tr><td>1.705-30.0</td><td>30</td><td>30</td></tr>
<tr><td>30-88</td><td>100 **</td><td>3</td></tr>
<tr><td>88-216</td><td>150 **</td><td>3</td></tr>
<tr><td>216-960</td><td>200 **</td><td>3</td></tr>
<tr><td>Above 960</td><td>500</td><td>3</td></tr>
</table>
** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241.
</td></tr>
<tr><td>Procedure:</td><td>ANSI C63.10-2013 section 6.6.4</td></tr>
</table>

6.8.1 E.U.T. Operation:

Operating Environment:	
Temperature:	24.9 °C
Humidity:	49.4 %
Atmospheric Pressure:	1010 mbar

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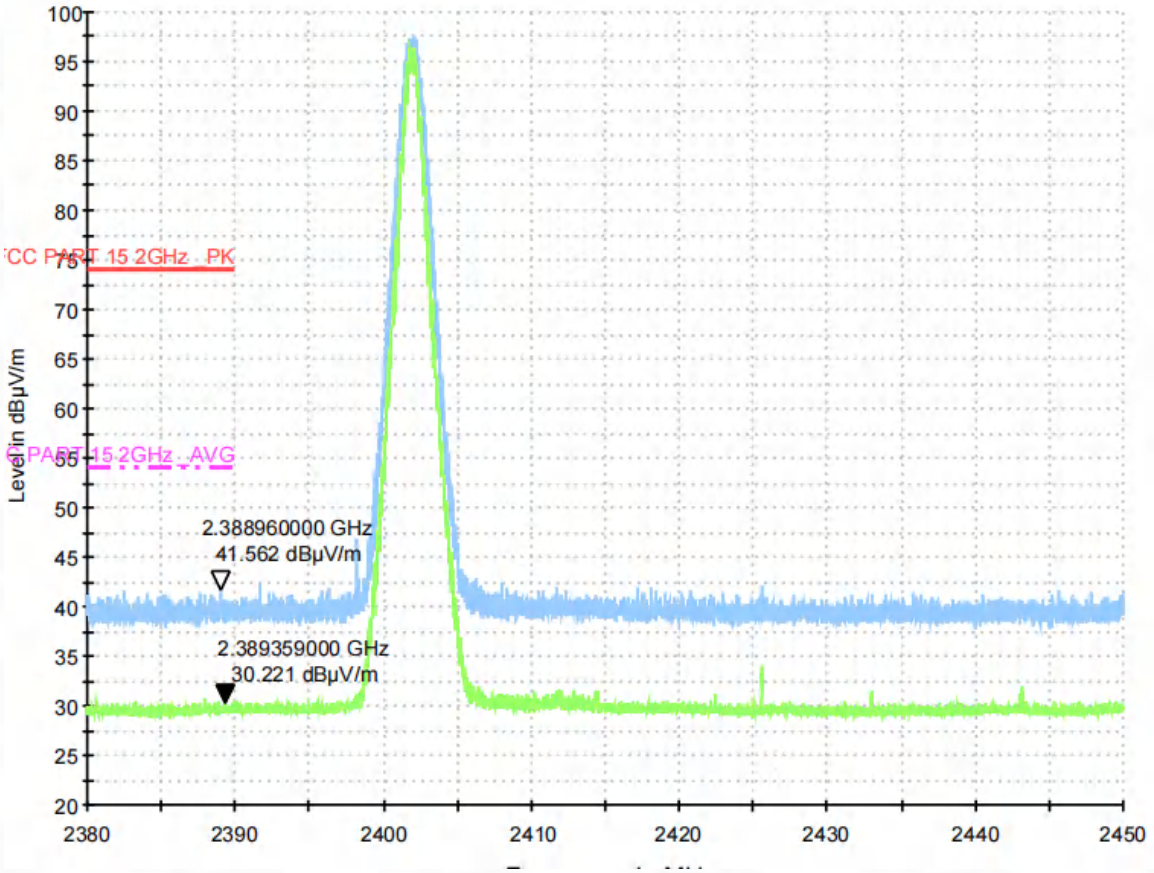
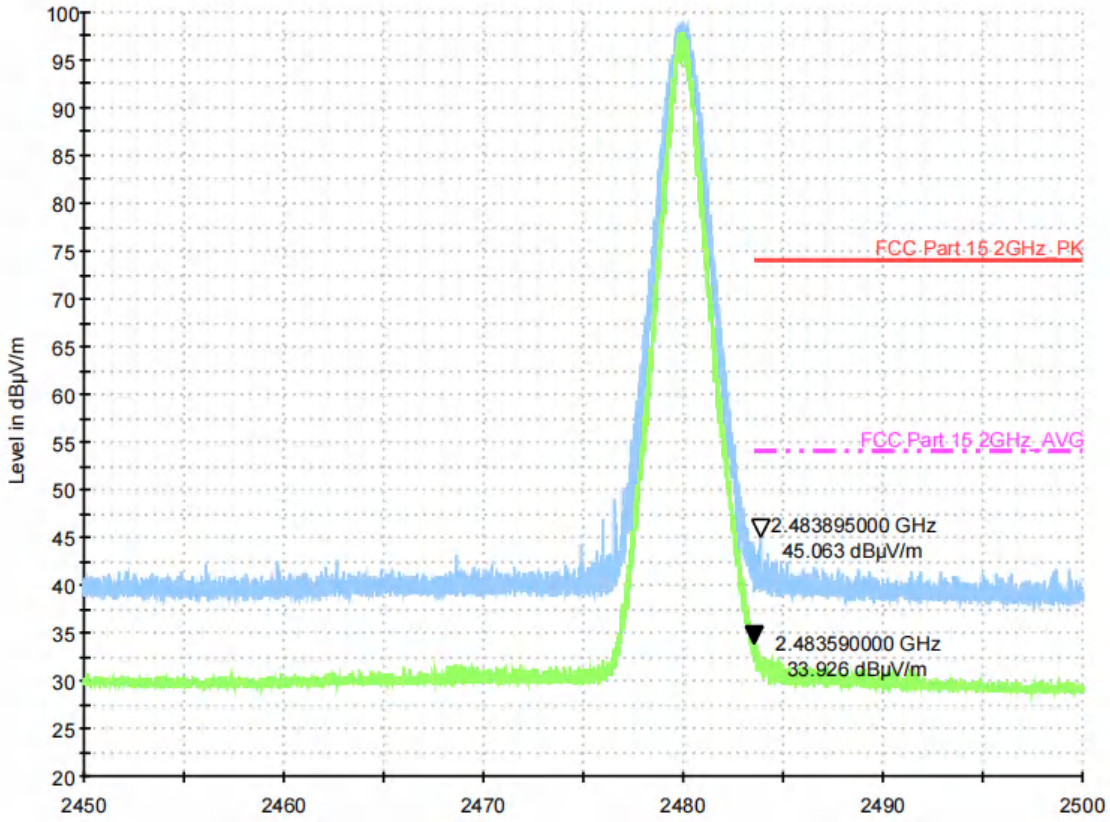
6.8.2 Test Data:

Worst test modulation 8DPSK

For Non-Hopping Mode:





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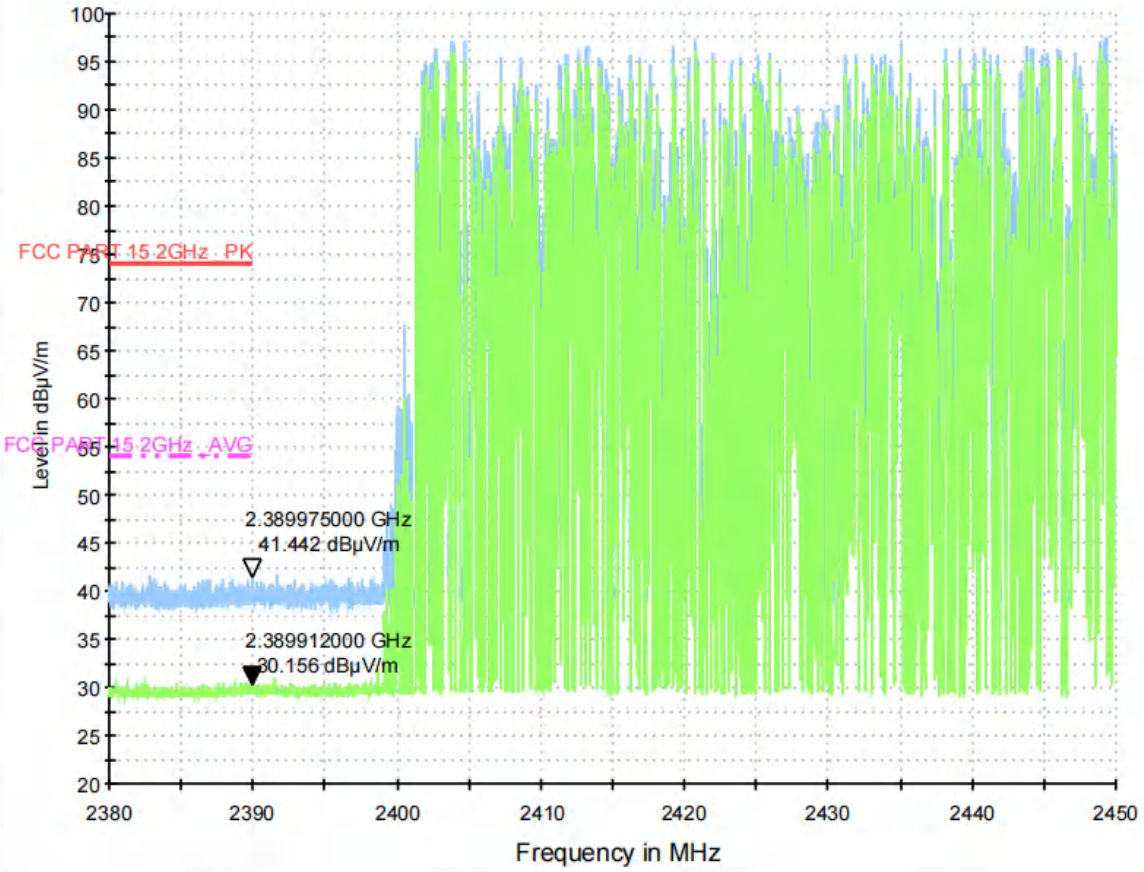
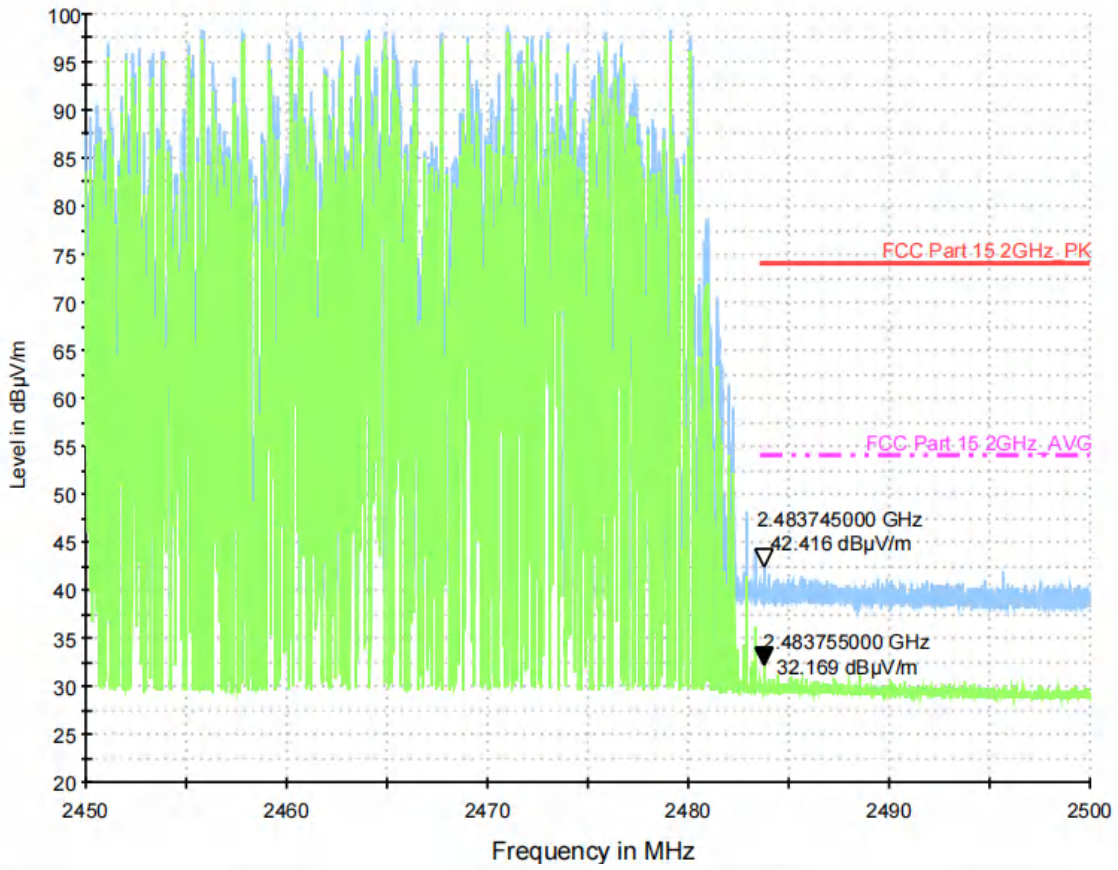
For Hopping Mode:





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6.9 Emissions in restricted frequency bands (below 1GHz)

Test Requirement:	In addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § 15.209(a)(see § 15.205(c)).`
Test Method:	Radiated emissions tests
Test Limit:	Frequency (MHz) / Field strength (microvolts/meter) / Measurement distance (meters) 0.009-0.490 / 2400/F(kHz) / 300 0.490-1.705 / 24000/F(kHz) / 30 1.705-30.0 / 30 / 30 30-88 / 100 ** / 3 88-216 / 150 ** / 3 216-960 / 200 ** / 3 Above 960 / 500 / 3 ** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241.
Procedure:	ANSI C63.10-2013 section 6.6.4

6.9.1 E.U.T. Operation:

Operating Environment:	
Temperature:	24.9 °C
Humidity:	49.4 %
Atmospheric Pressure:	1010 mbar

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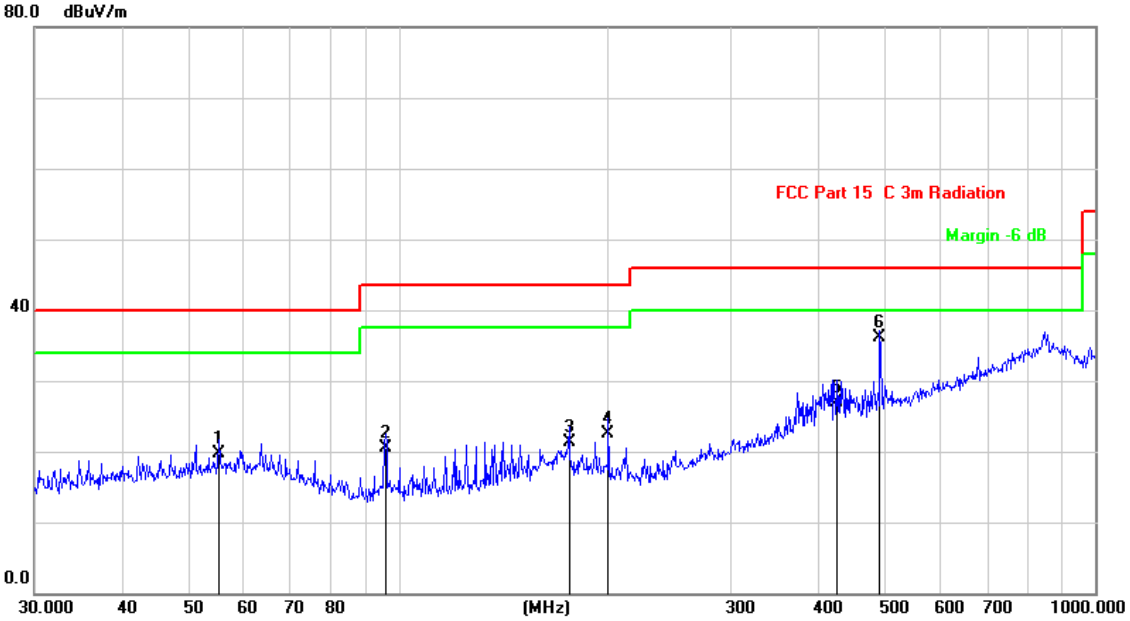
6.9.2 Test Data:

Vertical:



No.	Frequency (MHz)	Reading Level(dBuV)	Factor (dB)	Measure-ment(dBuV)	Limit (dBuV)	Over (dB)	Detector	Comment
1	55.2207	28.78	-9.08	19.70	40.00	-20.30	QP	
2	95.7622	32.54	-12.04	20.50	43.50	-23.00	QP	
3	175.6516	32.73	-11.43	21.30	43.50	-22.20	QP	
4	199.9856	33.89	-11.29	22.60	43.50	-20.90	QP	
5	426.5210	29.19	-2.19	27.00	46.00	-19.00	QP	
6 *	490.7447	37.62	-1.42	36.20	46.00	-9.80	QP	

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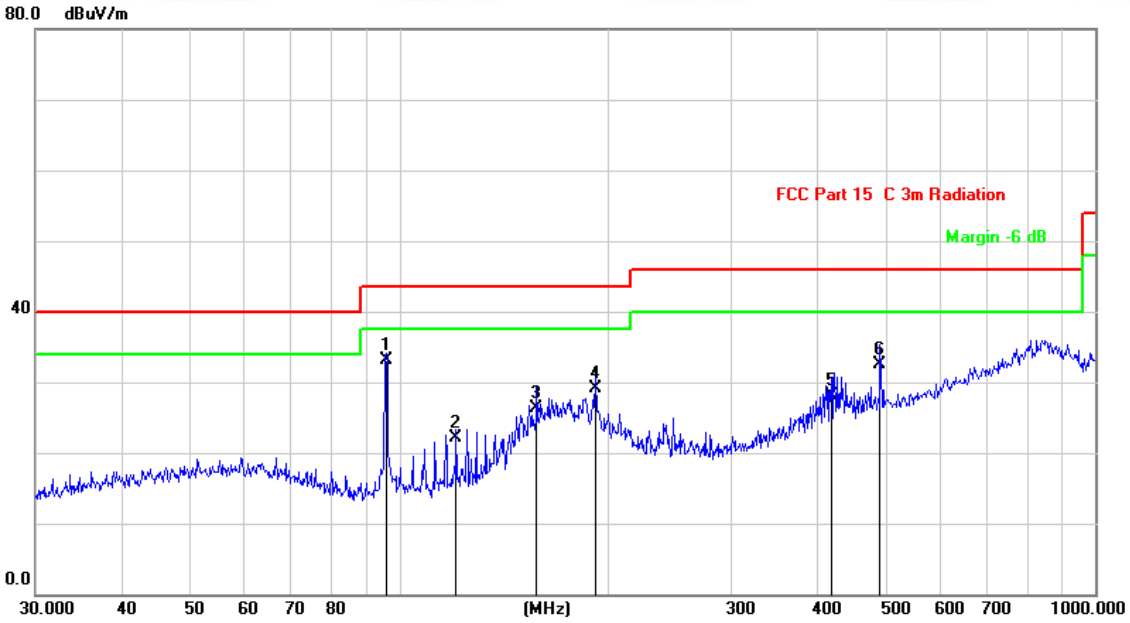
Horizontal:



No.	Frequency (MHz)	Reading Level(dBuV)	Factor (dB)	Measure-ment(dBuV)	Limit (dBuV)	Over (dB)	Detector	Comment
1 *	95.7622	45.14	-12.04	33.10	43.50	-10.40	QP	
2	120.6991	33.67	-11.57	22.10	43.50	-21.40	QP	
3	157.5588	37.78	-11.48	26.30	43.50	-17.20	QP	
4	191.7450	40.19	-11.09	29.10	43.50	-14.40	QP	
5	417.6411	30.72	-2.62	28.10	46.00	-17.90	QP	
6	490.7447	34.02	-1.42	32.60	46.00	-13.40	QP	

Remark: All modes have been tested, and only worst data of GFSK mode, Channel 2402MHz was listed in this report.

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6.10 Emissions in restricted frequency bands (above 1GHz)

<table>
<tr><td>Test Requirement:</td><td>In addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § 15.209(a)(see § 15.205(c)).`</td></tr>
<tr><td>Test Method:</td><td>Radiated emissions tests</td></tr>
<tr><td>Test Limit:</td><td>
<table>
<tr><td>Frequency (MHz)</td><td>Field strength (microvolts/meter)</td><td>Measurement distance (meters)</td></tr>
<tr><td>0.009-0.490</td><td>2400/F(kHz)</td><td>300</td></tr>
<tr><td>0.490-1.705</td><td>24000/F(kHz)</td><td>30</td></tr>
<tr><td>1.705-30.0</td><td>30</td><td>30</td></tr>
<tr><td>30-88</td><td>100 **</td><td>3</td></tr>
<tr><td>88-216</td><td>150 **</td><td>3</td></tr>
<tr><td>216-960</td><td>200 **</td><td>3</td></tr>
<tr><td>Above 960</td><td>500</td><td>3</td></tr>
</table>
** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241.
</td></tr>
<tr><td>Procedure:</td><td>ANSI C63.10-2013 section 6.6.4</td></tr>
</table>

6.10.1E.U.T. Operation:

Operating Environment:	
Temperature:	24.9 °C
Humidity:	49.4 %
Atmospheric Pressure:	1010 mbar

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6.10.2Test Data:

From 1G-25GHz

Test Mode: GFSK TX Low									
Freq (MHz)	Read Level (dBuV/m)	Polar (H/V)	Antenna Factor (dB/m)	Cable loss(dB)	Amp Factor (dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
4804	48.20	V	33.93	10.18	34.26	58.05	74	-15.95	PK
4804	36.93	V	33.93	10.18	34.26	46.78	54	-7.22	AV
7206	/	/	/	/	/	/	/	/	/
9608	/	/	/	/	/	/	/	/	/
4804	47.56	H	33.93	10.18	34.26	57.41	74	-16.59	PK
4804	35.74	H	33.93	10.18	34.26	45.59	54	-8.41	AV
7206	/	/	/	/	/	/	/	/	/
9608	/	/	/	/	/	/	/	/	/
Test Mode: GFSK TX Mid									
4882	49.89	V	33.95	10.20	34.26	59.78	74	-14.22	PK
4882	35.20	V	33.95	10.20	34.26	45.09	54	-8.91	AV
7323	/	/	/	/	/	/	/	/	/
9764	/	/	/	/	/	/	/	/	/
4882	48.26	H	33.95	10.20	34.26	58.15	74	-15.85	PK
4882	34.52	H	33.95	10.20	34.26	44.41	54	-9.59	AV
7323	/	/	/	/	/	/	/	/	/
9764	/	/	/	/	/	/	/	/	/
Test Mode: GFSK TX High									
4960	47.33	V	33.98	10.22	34.25	57.28	74	-16.72	PK
4960	33.98	V	33.98	10.22	34.25	43.93	54	-10.07	AV
7440	/	/	/	/	/	/	/	/	/
9920	/	/	/	/	/	/	/	/	/
4960	46.63	H	33.98	10.22	34.25	56.58	74	-17.42	PK
4960	32.08	H	33.98	10.22	34.25	42.03	54	-11.97	AV
7440	/	/	/	/	/	/	/	/	/
9920	/	/	/	/	/	/	/	/	/

Note:
1, Result = Read level + Antenna factor + cable loss-Amp factor
2, All the other emissions not reported were too low to read and deemed to comply with FCC limit.

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Test Mode: π/4 DQPSK TX Low									
Freq (MHz)	Read Level (dBuV/m)	Polar (H/V)	Antenna Factor (dB/m)	Cable loss(dB)	Amp Factor (dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
4804	48.94	V	33.93	10.18	34.26	58.79	74	-15.21	PK
4804	36.54	V	33.93	10.18	34.26	46.39	54	-7.61	AV
7206	/	/	/	/	/	/	/	/	/
9608	/	/	/	/	/	/	/	/	/
4804	47.73	H	33.93	10.18	34.26	57.58	74	-16.42	PK
4804	35.32	H	33.93	10.18	34.26	45.17	54	-8.83	AV
7206	/	/	/	/	/	/	/	/	/
9608	/	/	/	/	/	/	/	/	/
Test Mode: π/4 DQPSK TX Mid									
4882	49.94	V	33.95	10.20	34.26	59.83	74	-14.17	PK
4882	35.07	V	33.95	10.20	34.26	44.96	54	-9.04	AV
7323	/	/	/	/	/	/	/	/	/
9764	/	/	/	/	/	/	/	/	/
4882	48.97	H	33.95	10.20	34.26	58.86	74	-15.14	PK
4882	34.08	H	33.95	10.20	34.26	43.97	54	-10.03	AV
7323	/	/	/	/	/	/	/	/	/
9764	/	/	/	/	/	/	/	/	/
Test Mode: π/4 DQPSK TX High									
4960	47.32	V	33.98	10.22	34.25	57.27	74	-16.73	PK
4960	33.44	V	33.98	10.22	34.25	43.39	54	-10.61	AV
7440	/	/	/	/	/	/	/	/	/
9920	/	/	/	/	/	/	/	/	/
4960	46.67	H	33.98	10.22	34.25	56.62	74	-17.38	PK
4960	32.62	H	33.98	10.22	34.25	42.57	54	-11.43	AV
7440	/	/	/	/	/	/	/	/	/
9920	/	/	/	/	/	/	/	/	/

Note:
1, Result = Read level + Antenna factor + cable loss-Amp factor
2, All the other emissions not reported were too low to read and deemed to comply with FCC limit.

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Test Mode: 8DPSK TX Low									
Freq (MHz)	Read Level (dBuV/m)	Polar (H/V)	Antenna Factor (dB/m)	Cable loss(dB)	Amp Factor (dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
4804	48.44	V	33.93	10.18	34.26	58.29	74	-15.71	PK
4804	36.20	V	33.93	10.18	34.26	46.05	54	-7.95	AV
7206	/	/	/	/	/	/	/	/	/
9608	/	/	/	/	/	/	/	/	/
4804	47.80	H	33.93	10.18	34.26	57.65	74	-16.35	PK
4804	35.76	H	33.93	10.18	34.26	45.61	54	-8.39	AV
7206	/	/	/	/	/	/	/	/	/
9608	/	/	/	/	/	/	/	/	/
Test Mode: 8DPSK TX Mid									
4882	49.63	V	33.95	10.20	34.26	59.52	74	-14.48	PK
4882	35.75	V	33.95	10.20	34.26	45.64	54	-8.36	AV
7323	/	/	/	/	/	/	/	/	/
9764	/	/	/	/	/	/	/	/	/
4882	48.15	H	33.95	10.20	34.26	58.04	74	-15.96	PK
4882	34.31	H	33.95	10.20	34.26	44.20	54	-9.80	AV
7323	/	/	/	/	/	/	/	/	/
9764	/	/	/	/	/	/	/	/	/
Test Mode: 8DPSK TX High									
4960	47.86	V	33.98	10.22	34.25	57.81	74	-16.19	PK
4960	33.20	V	33.98	10.22	34.25	43.15	54	-10.85	AV
7440	/	/	/	/	/	/	/	/	/
9920	/	/	/	/	/	/	/	/	/
4960	46.88	H	33.98	10.22	34.25	56.83	74	-17.17	PK
4960	32.70	H	33.98	10.22	34.25	42.65	54	-11.35	AV
7440	/	/	/	/	/	/	/	/	/
9920	/	/	/	/	/	/	/	/	/

Note:
1, Result = Read level + Antenna factor + cable loss-Amp factor
2, All the other emissions not reported were too low to read and deemed to comply with FCC limit.

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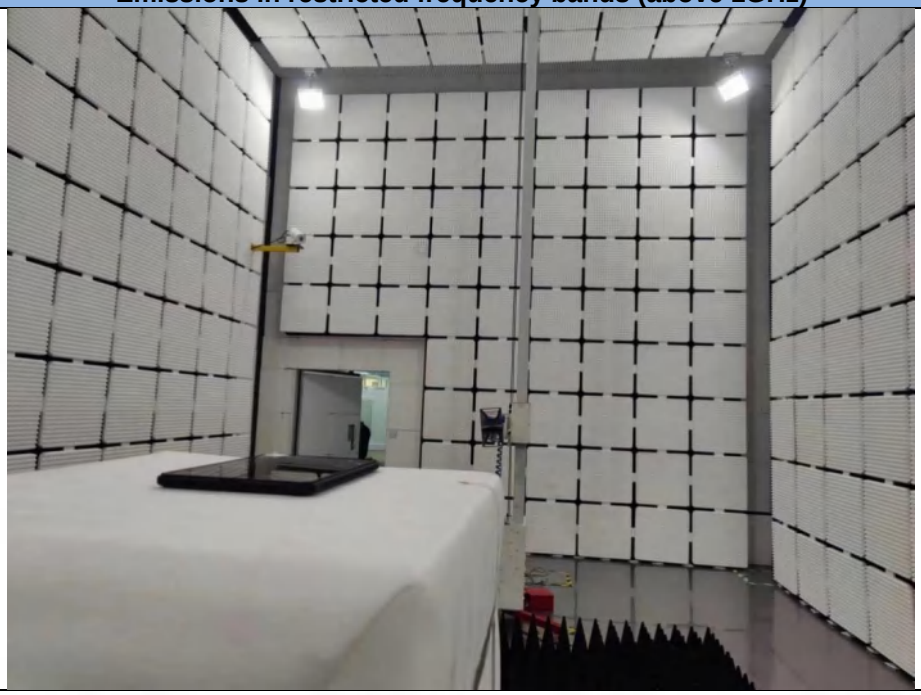
7 Test Setup Photos

Band edge emissions (Radiated)
Emissions in restricted frequency bands (above 1GHz)



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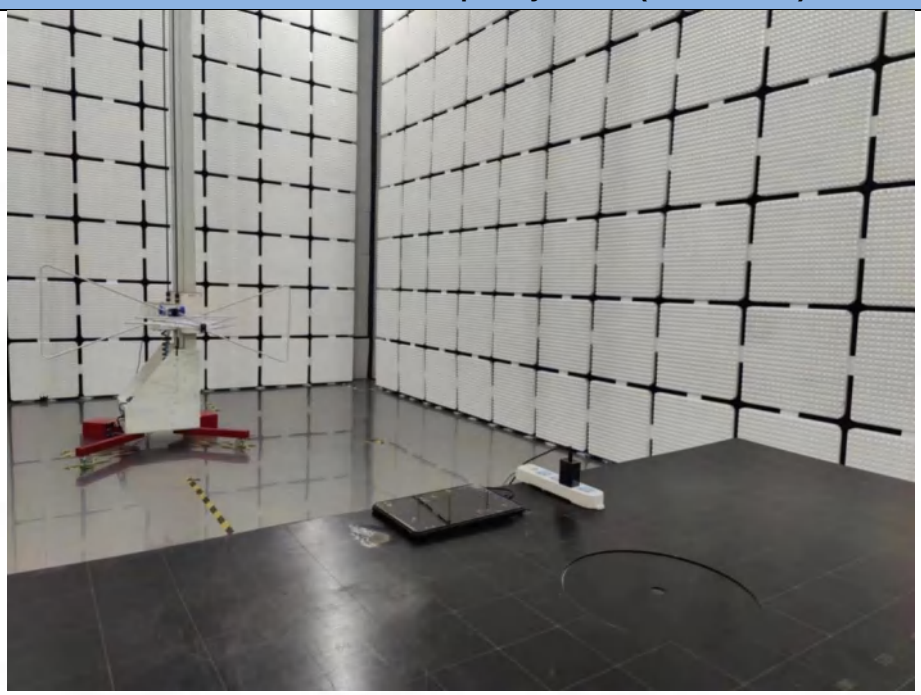
Emissions in restricted frequency bands (below 1GHz)


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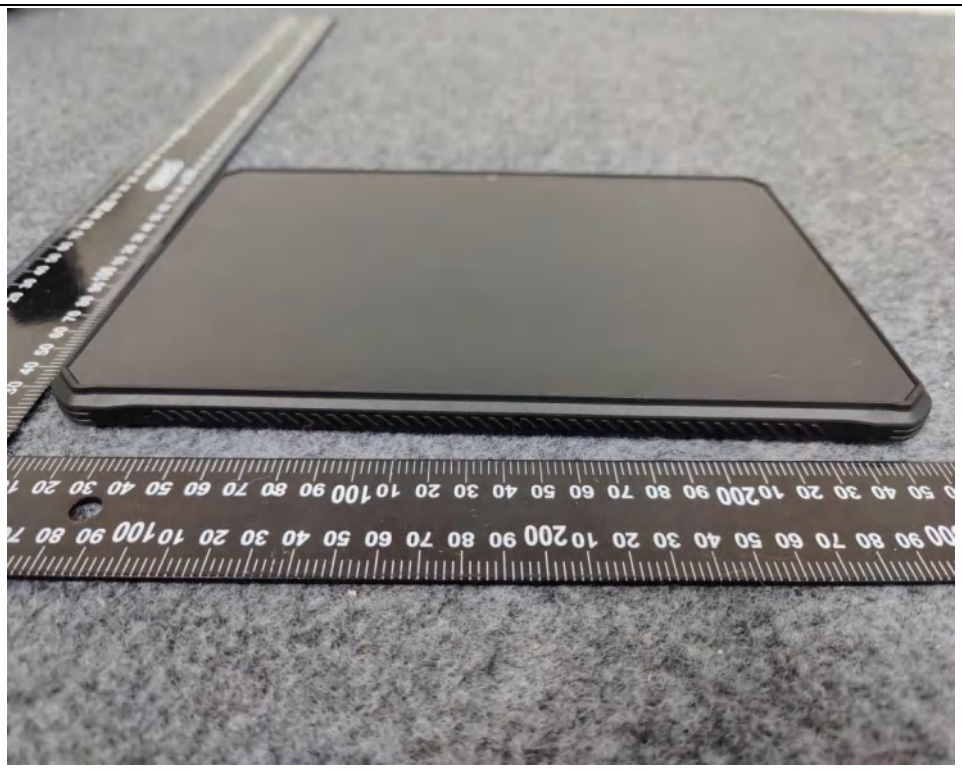
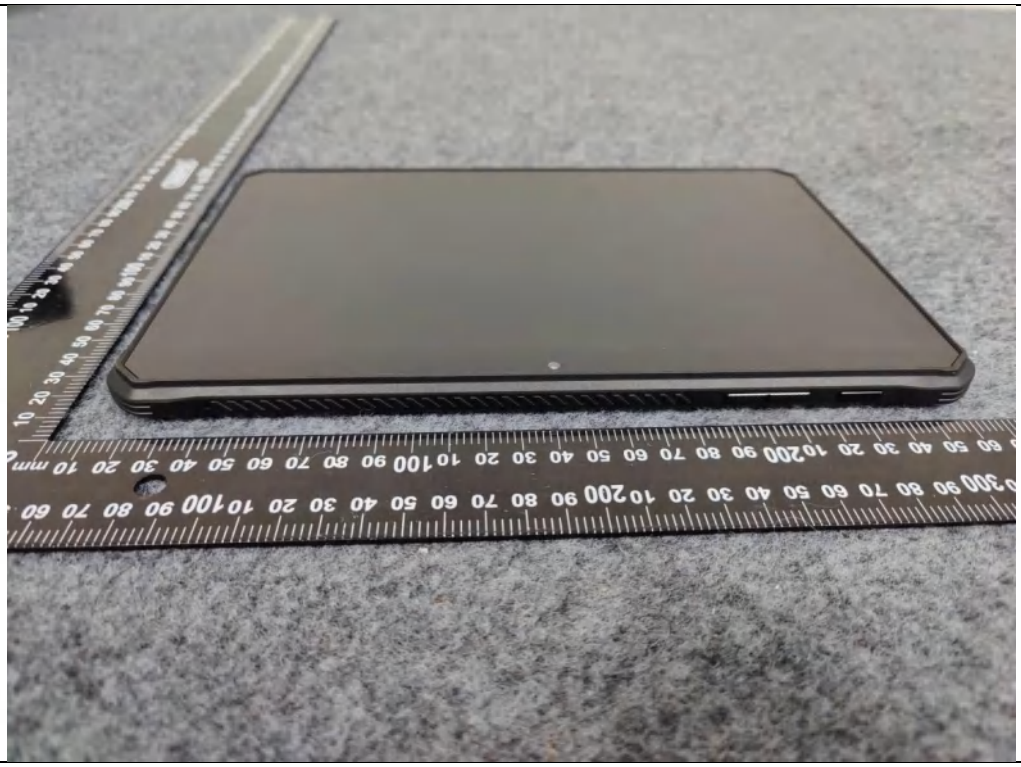
8 EUT Constructional Details (EUT Photos)





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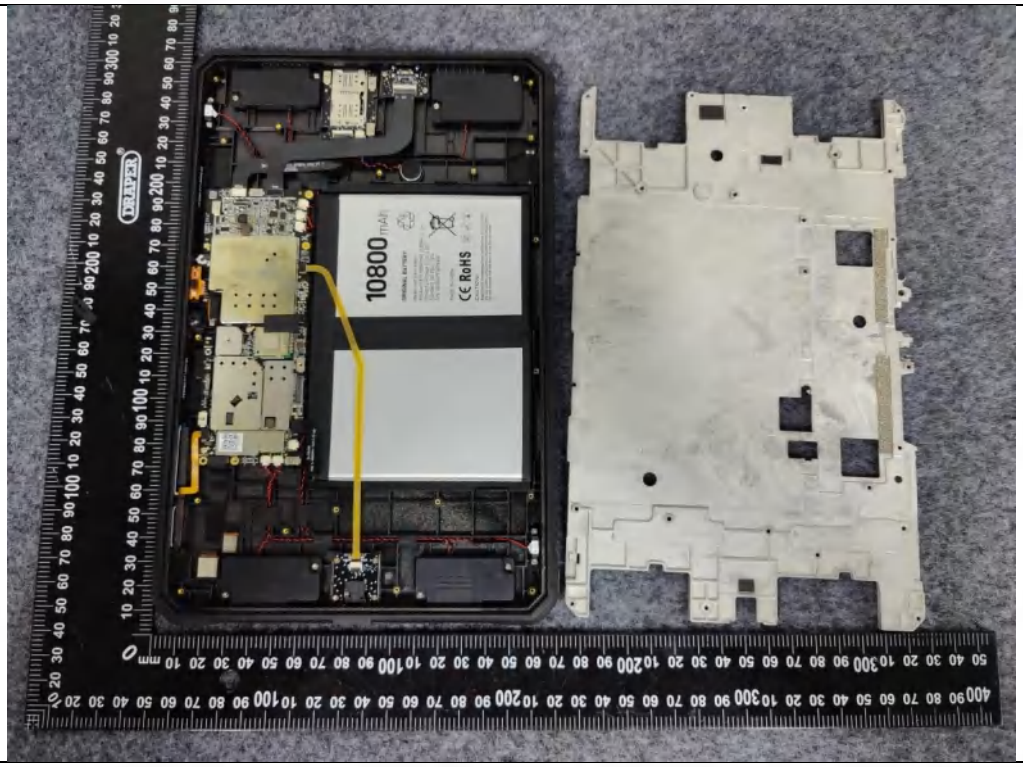
Internal


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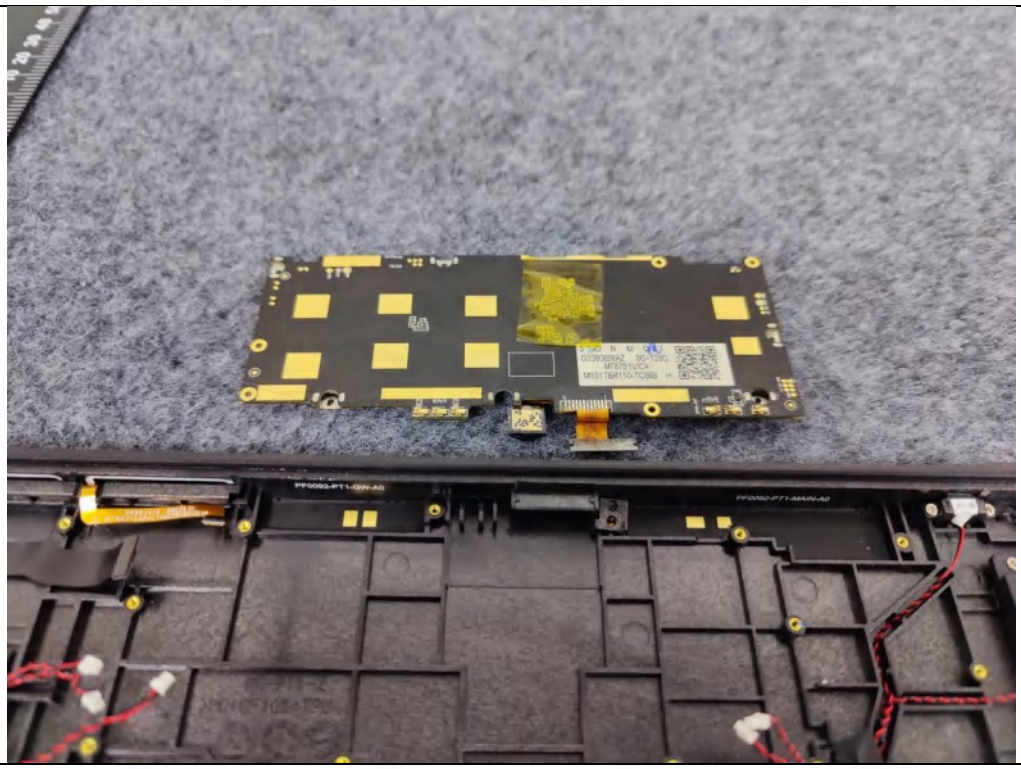

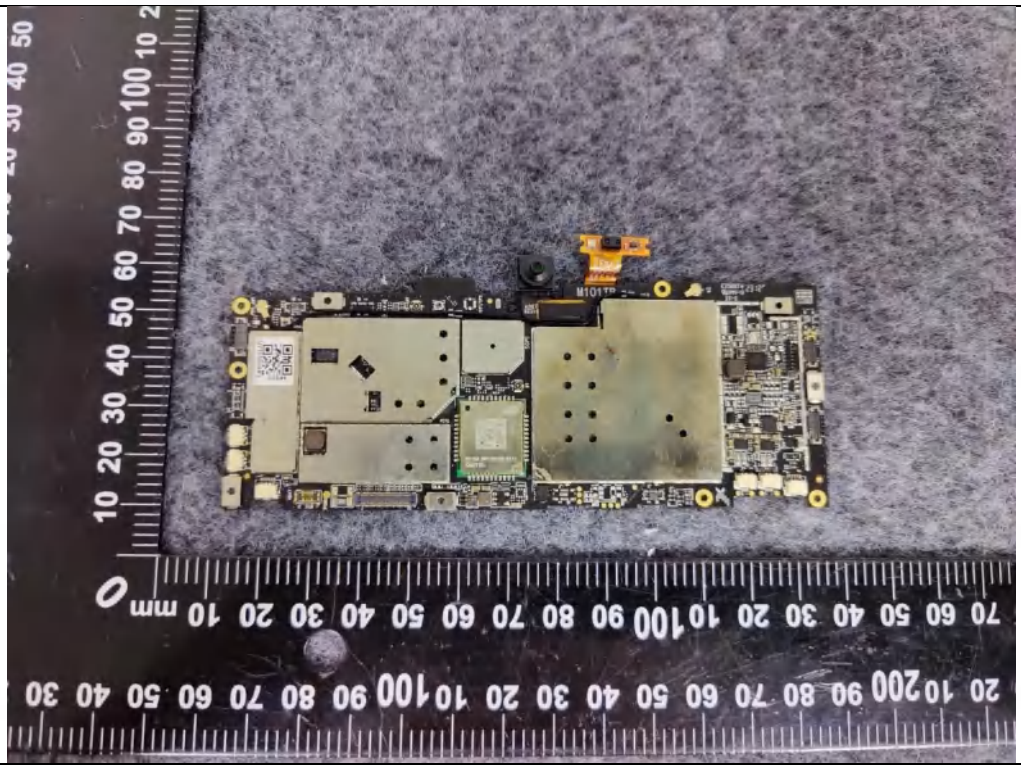

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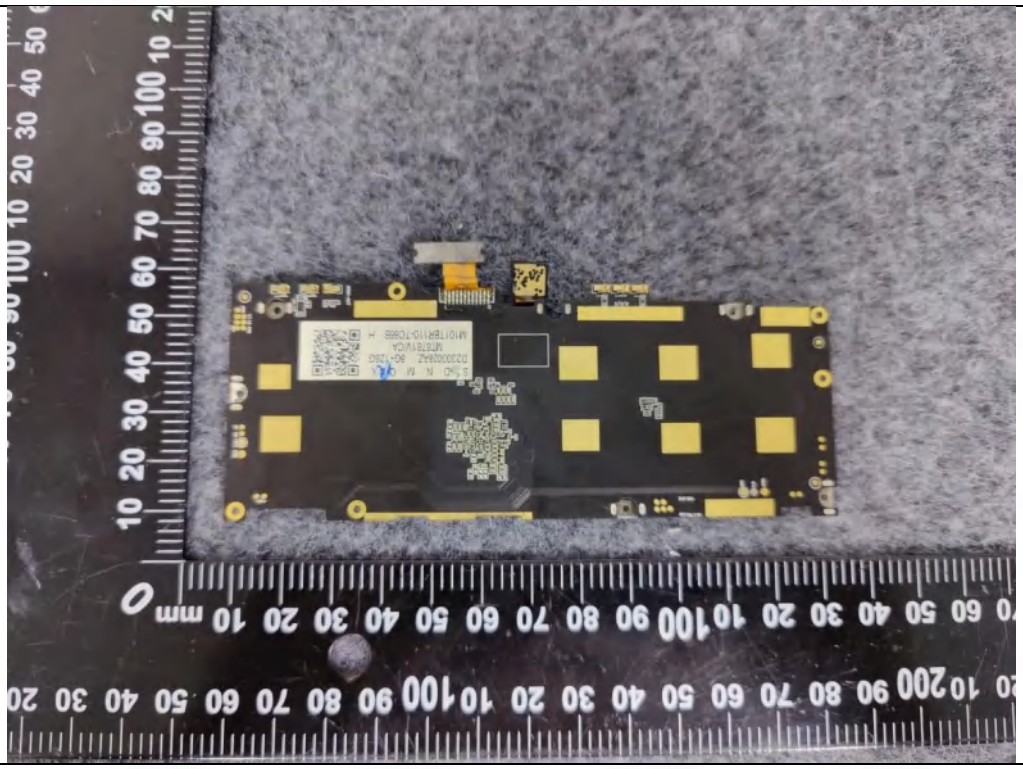

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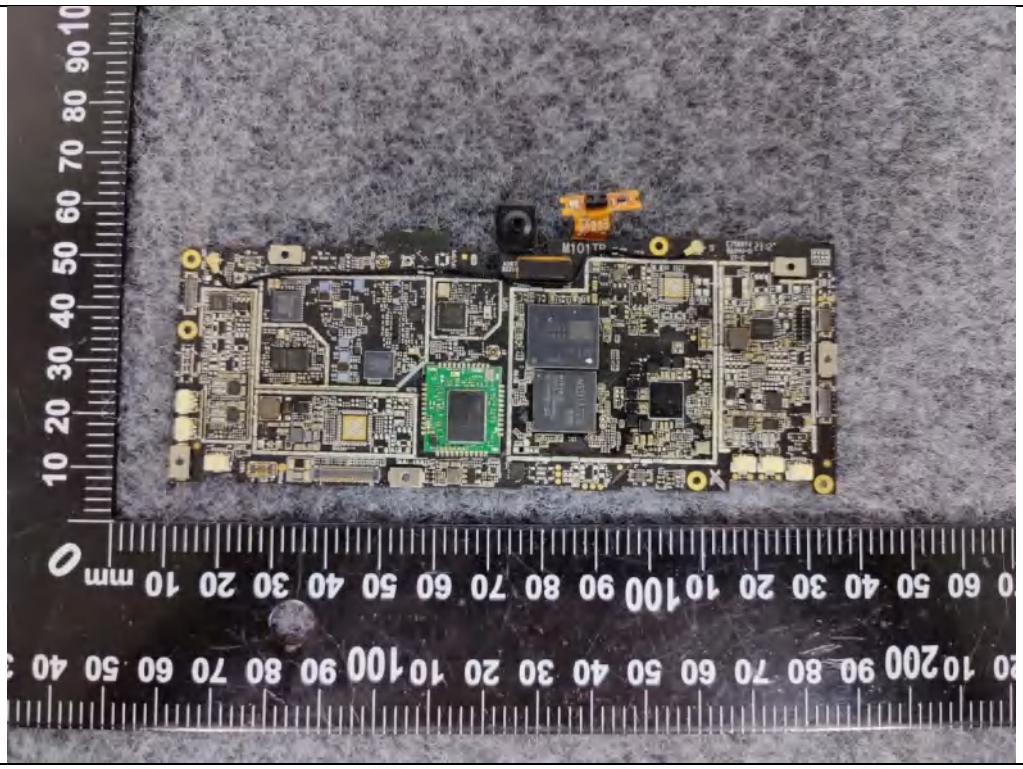

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